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SEMCON: A SEMICONDUCTOR DAMAGE DATA REDUCTION COMPUTER CODE. (U)

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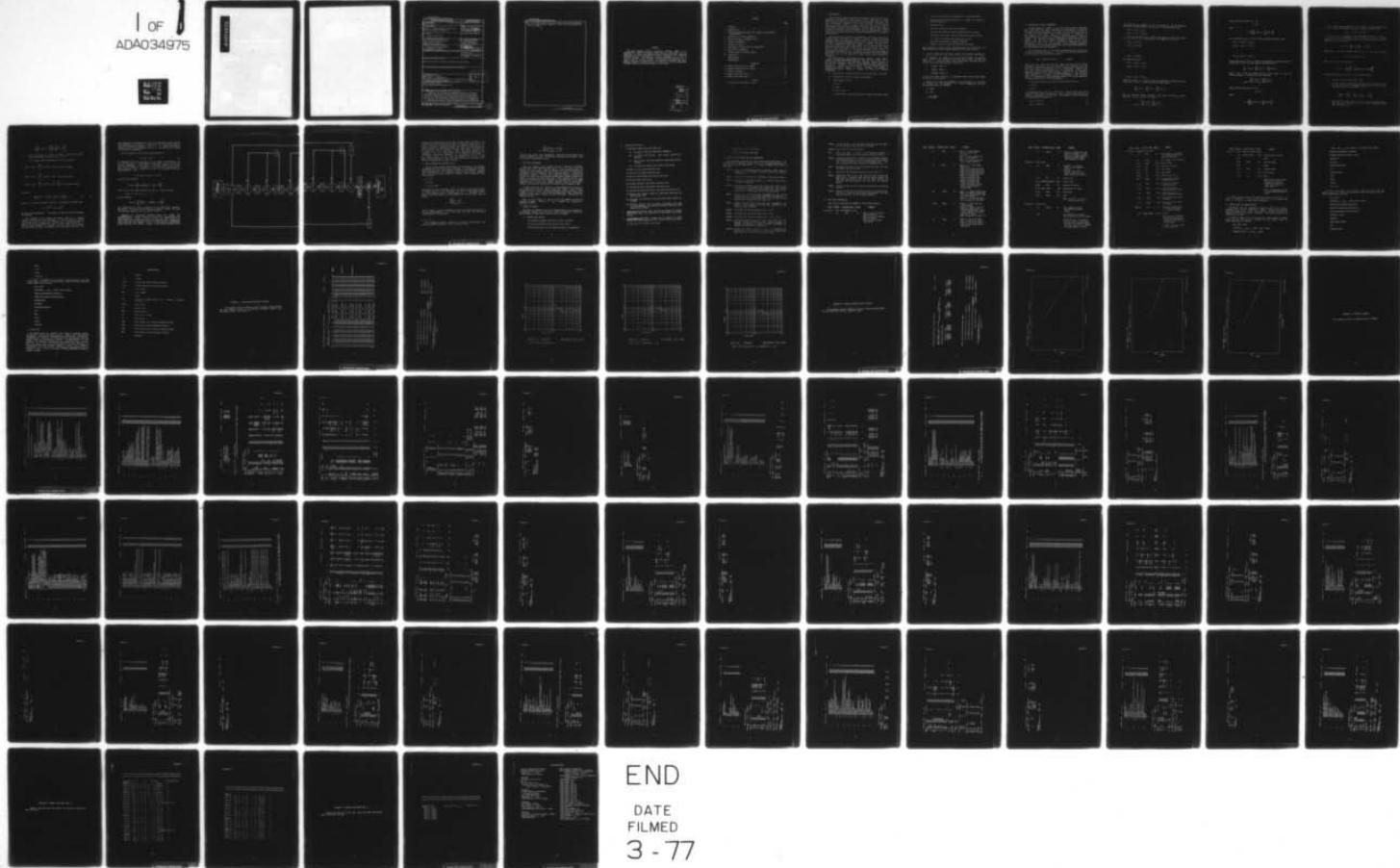
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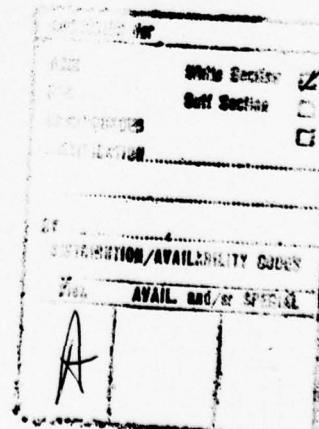
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plots of least-squares fits. This report details the development and capabilities of SEMCON, as well as the procedures for using the code.

FOREWORD

The Army Multiple Systems Evaluation Program (MSEP) is a comprehensive program developing general analytic techniques for the prediction of high electromagnetic-pulse vulnerability and hardening technology and for the application of these techniques to a list of critical systems. The analytic techniques have been verified for a large class of tactical systems. The hardening techniques have been applied to specific systems and are now resulting in product improvement programs leading to hardened equipment in the field.



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1. INTRODUCTION

This effort was written under the sponsorship of the Multiple Systems Evaluation Program (MSEP), which has as its main objective to harden Army tactical systems to the electromagnetic pulse (EMP) associated with the exoatmospheric detonation of a nuclear weapon. Along with this major objective, MSEP is tasked also with the aim to develop experimental and analytical evaluation techniques that are applicable to all systems' problems. These objectives are satisfied, since SEMCON provides an analytic method to examine various semiconductor devices used in Army systems and assists in making recommendations for hardening modifications.

When making EMP vulnerability assessments, it is often necessary to perform a circuit analysis on specific circuits driven by a voltage induced by EMP. This analysis often points out a large power value produced on various semiconductor devices that could cause the devices to fail if sufficient power were present. However, to know if a particular device fails and at what power level, a semiconductor device must be analyzed and a damage curve fitted to certain data. This curve gives a good indication as to the vulnerability of the device to particular thresholds of power. Therefore, the main purpose of computer code SEMCON is to provide the necessary information about semiconductor devices so that it is possible to make various EMP vulnerability assessments.

The semiconductor damage-data-reduction computer code, SEMCON, analyzes various semiconductor devices. The code was written for a Control Data Corporation (CDC) 6600 series computer system located at the Mobility Equipment Research and Development Center (MERDC), Fort Belvoir, VA. Written to run employing the FTN compiler, SEMCON is operational using the SCOPE 3.4.3 control language. To evaluate a semiconductor device, SEMCON is capable of giving the following information:

- a. Determination of damage--the failure or nonfailure of a device
- b. Calculations of power, energy, and impedance
- c. Least-squares fits of

$$P = at^{-1},$$

$$P = bt^{-\frac{1}{2}},$$

$$P = at^{-1} + bt^{-\frac{1}{2}}$$

to either power versus failure time or power versus pulse width

- d. Selection of the best least-squares fit to specified data
- e. Log-log plots of least-squares fits in either the forward or reverse direction
- f. Log-log plots of
 - TD versus Z--failure time versus impedance
 - TD versus VOC--failure time versus open-circuit voltage
 - TDOC versus VOC--pulse duration versus open-circuit voltage
 - TD versus IP--failure time versus peak current
in either the forward or reverse direction
- g. Tabular listing of input data and all calculations

The subsequent sections detail the development and capabilities of SEMCON, along with the necessary information to utilize the code.

2. FAILURE DETERMINATION AND POWER, ENERGY, AND IMPEDANCE CALCULATIONS

To determine the damage on a particular pulse number, the specific values used in the calculations are (1) VZBP and VZAP, (2) VZBN and VZAN, and (3) GAINB and GAINA. The criteria used to determine failure are any one of the following three conditions:

- a. $.8*VZBP - VZAP > 0$
- b. $.8*VZBN - VZAN > 0$
- c. $.8*GAINB - GAINA > 0$

If any one of these conditions is satisfied, then for that pulse number the device is said to fail.

Another of the features of SEMCON is the calculations of the power (P), energy (E), and impedance (Z). These computations are very straightforward and are found by

$$P = VP * TD,$$

$$E = P * TD,$$

$$Z = \frac{VP - VZBP}{IP} .$$

3. DERIVATION OF FITTING PARAMETERS

The main purpose of SEMCON is to fit various curves to specified data. They are fit by using the method of least squares to calculate the various fitting parameters. The plots of these curves, as well as the data, are scaled logarithmically, since there can be a wide range in the values of the data. Thus, it is necessary to calculate the least-squares fits in terms of logarithms, which introduces a nonlinear problem. Two methods are used to calculate the least-squares fits in SEMCON. One uses the minimizing conditions known as the normal equations, and the other uses a minimization technique to find the minimum of a function of two variables. In the following paragraphs, the two methods are explained fully along with a detailed derivation of the least-squares fitting parameters.

The first method used to find the least-squares fits involves the solution of the normal equations. This technique involves substituting the n data pairs into the fitting equation.

$$f(x) = a_1\phi_1(x) + a_2\phi_2(x) + \dots + a_k\phi_k(x),$$

where $\phi_i(x)$ are known functions of x , and a_i are the k linear fitting parameters, thus obtaining n linear equations with k unknowns. The next step is to multiply each equation by its corresponding coefficient of the first unknown, which results in n new equations. Adding these equations gives the first normal equation. This process is repeated k times with respect to each of the unknown parameters, so that we end up with k equations in k unknowns (the fitting parameters). The resulting system of simultaneous linear equations, known as the normal equations, is then solved for the k fitting parameters.

In our particular case, we wish to use this method to fit

$$p = at^{-1},$$

$$p = bt^{-\frac{1}{2}}$$

to experimental data, where p is the power, t is the failure time, and a and b are the fitting parameters. Since plots are desired that are scaled logarithmically, we must find the parameters a and b by applying the least-squares technique to

$$\log p = \log at^{-1}, \quad (1)$$

$$\log p = \log bt^{-\frac{1}{2}}. \quad (2)$$

All logarithms are assumed to be to the base 10. By the elementary properties of logarithms, we clearly have a linear problem, since

$$\log p = \log a - \log t,$$

$$\log p = \log b - \frac{1}{2} \log t.$$

First, we consider $\log p = \log at^{-1}$ and suppose we have n data pairs (t_i, p_i) for $1 \leq i \leq n$. Substituting into equation (1), we get

$$\log p_1 = \log at_1^{-1},$$

$$\log p_2 = \log at_2^{-1},$$

.

.

.

$$\log p_n = \log at_n^{-1},$$

and simplifying gives

$$\log p_1 = \log a - \log t_1,$$

$$\log p_2 = \log a - \log t_2,$$

.

.

.

$$\log p_n = \log a - \log t_n.$$

Since this system is linear in terms of logarithms, multiplying by the coefficient of $\log a$ in each equation and adding gives

$$\sum_{i=1}^n \log p_i = \sum_{i=1}^n \log a - \sum_{i=1}^n \log t_i.$$

This is the only normal equation, since there is only one fitting parameter. Solving for $\log a$, we obtain

$$\log a = \frac{\sum_{i=1}^n \log p_i + \sum_{i=1}^n \log t_i}{n},$$

which gives the solution for a as

$$a = 10^x ,$$

where

$$x = \frac{1}{n} \left(\sum_{i=1}^n \log p_i + \sum_{i=1}^n \log t_i \right).$$

Now, considering $\log p = \log b - \frac{1}{2} \log t$ and proceeding as above, we get

$$\log p_1 = \log b - \frac{1}{2} \log t_1 ,$$

$$\log p_2 = \log b - \frac{1}{2} \log t_2 ,$$

.

.

.

$$\log p_n = \log b - \frac{1}{2} \log t_n .$$

This system also is linear in terms of logarithms, so multiplying by the coefficient of $\log b$ in each equation and adding gives

$$\sum_{i=1}^n \log p_i = \sum_{i=1}^n \log b - \frac{1}{2} \sum_{i=1}^n \log t_i .$$

Again, this is the only normal equation, since there is only one fitting parameter. Solving for $\log b$, we obtain

$$\log b = \frac{\sum_{i=1}^n \log p_i + \frac{1}{2} \sum_{i=1}^n \log t_i}{n} ,$$

which gives the solution for b as

$$b = 10^y ,$$

where

$$y = \frac{1}{n} \left(\sum_{i=1}^n \log p_i + \frac{1}{2} \sum_{i=1}^n \log t_i \right) .$$

The second method employed to calculate the least-squares fits involves finding a minimum of a function. Suppose we want to fit

$$f(x) = a_1\phi_1(x) + a_2\phi_2(x)$$

to n data points, where $\phi_1(x)$, $\phi_2(x)$ are known functions of x , and a_1 , a_2 are the fitting parameters. Let $\bar{f}_i = \bar{f}(x_i)$ for $1 \leq i \leq n$ be the experimental data that we wish to fit. Then by the principle of least squares, we want to minimize

$$F(a_1, a_2) = \sum_{i=1}^n w(x_i) [\bar{f}_i - f(x_i)]^2,$$

where $w(x_i)$ is the weight function for each x_i . For our case, we choose

$$w(x_i) = 1 \text{ for } 1 \leq i \leq n.$$

Thus, we must find the minimum of

$$F(a_1, a_2) = \sum_{i=1}^n \left\{ \bar{f}_i - [a_1\phi_1(x_i) + a_2\phi_2(x_i)] \right\}^2.$$

To find the minimum, we proceed in the following manner:

- a. Start with initial values $a_1^{(0)}$, $a_2^{(0)}$.
- b. At the i th step, halve $a_1^{(i)}$, and try to step first in the positive and then in the negative x -direction, to see if either resulting value gives a minimum, i.e.,

$$F\left[a_1^{(i)} \pm \frac{a_1^{(i)}}{2}, a_2^{(i)}\right] < F[a_1^{(i)}, a_2^{(i)}].$$

- c. Halve $a_2^{(i)}$, and try to step first in the positive and then in the negative y -direction, to see if either resulting value gives a minimum, i.e.,

$$F\left[a_1^{(i)}, a_2^{(i)} \pm \frac{a_2^{(i)}}{2^j}\right] < F\left[a_1^{(i)}, a_2^{(i)}\right].$$

d. If neither (b) nor (c) gives a minimum halve $a_1^{(i)}$ and $a_2^{(i)}$ again, and repeat (b) and (c), i.e., $j = 2$.

e. If a minimum results from either (b) or (c), then let

$$a_1^{(i+1)} = a_1^{(i)} \pm \frac{a_1^{(i)}}{2^j}, \quad a_2^{(i+1)} = a_2^{(i)}, \text{ if only (b) holds,}$$

$$a_2^{(i+1)} = a_2^{(i)} \pm \frac{a_2^{(i)}}{2^j}, \quad a_1^{(i+1)} = a_1^{(i)}, \text{ if only (c) holds,}$$

$$a_1^{(i+1)} = a_1^{(i)} \pm \frac{a_1^{(i)}}{2^j}, \quad a_2^{(i+1)} = a_2^{(i)} \pm \frac{a_2^{(i)}}{2^j}, \text{ if (b) and (c) hold,}$$

and check

$$\left| F\left[a_1^{(i+1)}, a_2^{(i+1)}\right] - F\left[a_1^{(i)}, a_2^{(i)}\right] \right| < \epsilon, \quad (3) \quad (3)$$

where ϵ is a chosen convergence tolerance. If equation (3) holds, then

$$a_1 + a_1^{(i+1)}, \quad a_2 = a_2^{(i+1)}$$

are the fitting parameters. If equation (3) does not hold, the process is repeated.

This technique is very simple and always leads to a minimum although it may be only a local minimum. If a local minimum is reached which is not close to the true minimum, then it seems reasonable to assume that the least-squares fit will be poor. Thus, when the fit is bad, it could probably be attributed to this distant local minimum, although there are other occurrences that could cause a bad fit. The

only solution to this problem is to try the minimization technique again with different initial values. A repetition of this process leads to the true minimum of the function $F(a_1, a_2)$. The above technique was limited to two fitting parameters, but it is an easy matter to extend this method to k parameters.

For our purpose, we wish to use this method to fit

$$p = at^{-1} + bt^{-\frac{1}{2}} \quad (4)$$

to experimental data (t_i, \bar{p}_i) for $1 \leq i \leq n$, where p is the power, t is the failure time, n is the number of data points, and a and b are the fitting parameters. This poses a nonlinear problem, since $\log(at^{-1} + bt^{-\frac{1}{2}})$ cannot be linearized as was $\log(at^{-1})$ and $\log(bt^{-\frac{1}{2}})$. This problem is easily overcome by using the minimization technique described above. Let

$$P(t; a, b) = \log(at^{-1} + bt^{-\frac{1}{2}}),$$

and we want to minimize

$$S(a, b) = \sum_{i=1}^n w(t_i) \left[\log \bar{p}_i - P(t_i; a, b) \right]^2,$$

where $w(t_i)$ is the weight function for each t_i . Since we choose

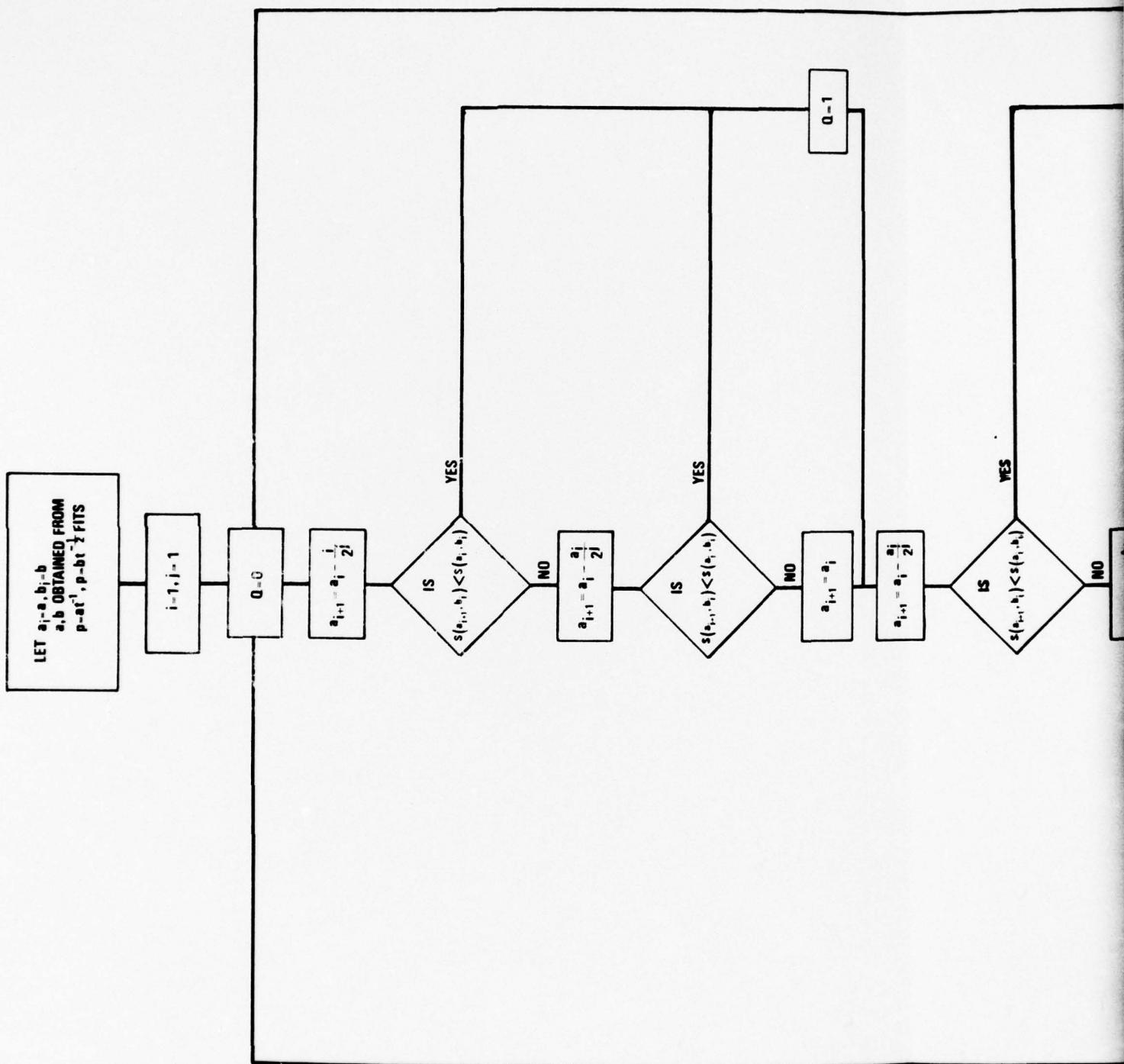
$$w(t_i) = 1 \text{ for } i = 1, 2, \dots, n,$$

we must minimize

$$S(a, b) = \sum_{i=1}^n \left[\log \bar{p}_i - \log(at_i^{-1} + bt_i^{-\frac{1}{2}}) \right]^2.$$

The minimization for $S(a, b)$ is identical to the minimization technique given above. A flow chart for finding the minimum of $S(a, b)$ and thus the fitting parameters a and b is given in figure 1.

Although the techniques outlined above are simple and straightforward, caution should be taken when interpreting the least-squares fits. First, the fits are only as good as the data. Poorly taken and recorded data result in meaningless fits. Probably the major fault with least squares is that a single very wrong measurement greatly distorts the results, because in the squaring process, large



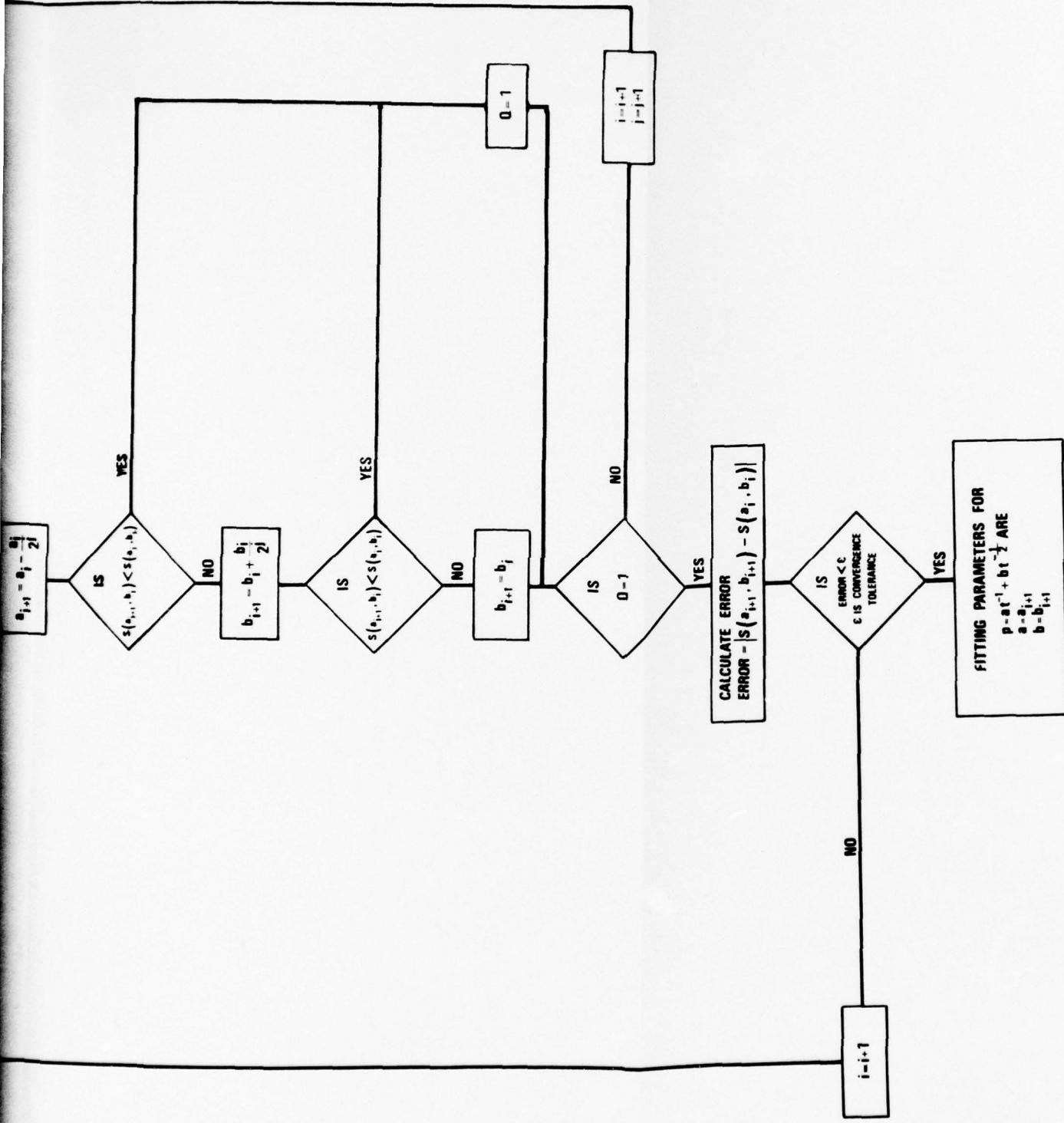


Figure 1. Flow chart for minimizing $S(a,b)$.

residuals are dominant--one gross error 10 times larger than most of the others has the same effect in the sum of the squares as have 100 of the others.¹ Second, a considerable amount of mathematical and statistical sophistication can be employed to give the fits much more reliability when the proper data are involved. Several statistical techniques can be applied to these least-squares fits that would enhance their assurance. One is a statistical test of hypothesis concerning the confidence in the fitting parameters a , b in equations (1), (2), and (4). The other would be to test the goodness of fit by using the χ^2 statistical test. These two techniques can be utilized to make SEMCON's least-squares fits more reliable.

4. GAUSS CRITERION OF GOODNESS OF FIT

One of the main questions pertaining to least-squares fits concerns the goodness of fit of the curve to the data. This problem can be dealt with when using the least-squares technique, and probably the most widely used method is the χ^2 goodness of fit statistical test. Although the χ^2 test has not been utilized in SEMCON, a test to determine which of the curves

$$p = at^{-1}$$

$$p = bt^{-\frac{1}{2}}$$

$$p = at^{-1} + bt^{-\frac{1}{2}}$$

best fits the data is applied. This test, known as the Gauss criterion of goodness of fit, is now explained. Let p_i be an experimental value, p_i a value computed from a least-squares fit, n the number of data points, and m the number of fitting parameters in the relation. Then we define

$$\Omega = \frac{\sum_{i=1}^n (\bar{p}_i - p_i)^2}{n - m},$$

and the Gauss criterion of goodness of fit states that the best fit is the one that minimizes Ω . Since the plots of these fits are scaled logarithmically, we calculate

¹R. W. Hamming, *Numerical Methods for Scientists and Engineers*, 2nd edition, McGraw-Hill Book Co., Inc., New York (1973).

$$\Omega = \frac{\sum_{i=1}^n (\log \bar{p}_i - \log p_i)^2}{n - m}$$

and find the curve that minimizes Ω . Values of Ω are printed in the output of SEMCON, as well as the curve that best fits the data. This can be seen in appendices A and B.

5. PLOTTING INFORMATION

There are several ways to obtain the plots generated by SEMCON. Through MERDC, SEMCON has the capability to use a Cal Comp model 835 cathode ray tube (CRT) plotting system. This system takes plotting information from a magnetic tape and converts the data to be plotted to incremental plotter commands, which produce discrete, electron-beam deflections (relative to the x and y axes) and intensity variations on the face of a CRT. The CRT display is transmitted through a camera lens system and recorded on 35-mm microfilm. The exposed film is then processed, and the plots are recorded on a magnetic tape at the MERDC computer center. A call to the MERDC computer center is necessary to initiate the hard-copy processing of the plots from the magnetic tape.

In addition to the CRT plotting system, SEMCON has the ability to use a Mohawk Data Sciences (MDS) model 2400 remote batch terminal accompanied with a Houston Instruments COMPLOT plotting system. This system, located at the Harry Diamond Laboratories (HDL) Woodbridge Research Facility (WRF), enables all plots and output information to be received on site.

Each of the methods to obtain plots from SEMCON has different plotting software. Examples of this software are contained in appendices A and B.

6. OPTIONS OF SEMCON

The output of SEMCON can be varied substantially, so an analysis of the possible options for outputting various information is essential. The following is a description of the options available.

a. Tabular data options

- (1) Listing of tabular data only--no plots are given.
- (2) Listings of tabular data and plots are given.
- (3) Plots are given, but the tabular listing is suppressed.

b. Plotting selections

(1) Available items versus item plots are

- (a) TD versus Z--failure time versus impedance
- (b) TD versus VOC--failure time versus open-circuit voltage
- (c) TDOC versus VOC--pulse duration versus open-circuit voltage
- (d) TD versus IP--failure time versus peak current.

(2) Plots in the reverse direction only

(3) Plots in the forward direction only

(4) Plots in both forward and reverse directions

(5) No item versus item plots

(6) Reverse direction item versus item plots only

(7) Forward direction item versus item plots only

(8) Forward and reverse direction item versus item plots only

(9) Forward and reverse direction item versus item plots and least-squares fits

(10) Plots may be received on the MDS remote batch terminal or at MERDC.

(11) Plotting software may be either the regular Cal Comp plotting software or the software available through the MDS remote batch terminal.

c. Input data--The regular input data may be entered or a simpler form of input data that requires only pulse width versus power entires.

d. Least-squares fits--Three curves may be fitted to either failure time (TD) versus power (P) or pulse width versus power.

(1) Fit to $p = at^{-1}$ and $p = bt^{-\frac{1}{2}}$ only.

(2) Fit to $p = at^{-1} + bt^{-\frac{1}{2}}$ only.

(3) Fit to all three equations.

7. DESCRIPTION OF SEMCON AND ITS SUBROUTINES

The SEMCON code consists of a main program and 19 subroutines. The documentation of SEMCON is detailed by the following analysis of the main program and its subroutines. A listing of SEMCON can be found in appendix C.

SEMCN reads in the data and writes the tabular output seen in appendix A. It also makes the power, energy, and impedance calculations.

FAILUR calculates the failure or nonfailure of each pulse number.

FRFAIL separates the data with respect to failure in the reverse or forward directions.

DIRECT sets up the variables T and PP, which are used in the calculations of the three least-squares fits, with respect to either the forward or reverse direction. Also, DIRECT chooses which least-squares fit will be calculated.

WRITE outputs the various fitting parameters for the chosen least-squares fit. Also, some other useful information is written, such as the curve that best fits the data and the minimum of the function S(a,b) (sect. 4).

PLOTT contains all the plot titles and axes information and labels. This subroutine initiates the plotting of all curves by calling PWRITE.

ALSQAR calculates the fitting parameter for $p = at^{-1}$.

BLSQAR calculates the fitting parameter for $p = bt^{-\frac{1}{2}}$.

ABLSQAR calculates the fitting parameters for $p = at^{-1} + bt^{-\frac{1}{2}}$.

PWRITE performs the plotting using the Cal Comp model 835 CRT plotting system by calling the WRF library routines in TALPLOT. The subroutines SELPLOT, TALGRAF, and TALDATA of TALPLOT are referenced in PWRITE only.

SELPLOT selects the beam intensity of the Cal Comp model 835 microfilm plotter and also enables the user to choose if he wants the plots sent to the MDS system at WRF.

TALGRAF sets up the plot axes and labels and specifies the number of sets of data to be plotted on one graph.

TALDATA plots a set of (x,y) data pairs.

SORT sorts the data in array T of subroutine DIRECT in increasing order so that the plotting is done correctly.

GOODFIT calculates the sum of the squares of the difference between the experimental value and the corresponding value computed from a least-squares fit for each least-squares fit. This sum is used in the Gauss criterion of goodness of fit.

GAUSS Determines the best fit for the data by the Gauss criterion and outputs the correct fit.

SAB calculates the functional values of S(a,b) (sect. 4).

OWNDAT enables the user to enter only data for pulse width versus power input. It outputs these data by calling COLMNS and makes the appropriate calls to the other routines to calculate the least-squares fits and make the desired plots.

COLMNS outputs the data for pulse width versus power in increasing columns.

CHANGE changes the abscissa and ordinate titles to correspond with the use of data for pulse width versus power. It also enters those data into the plotting software.

8. DATA INPUT PREPARATION

Input cards are prepared for SEMCON in the following manner.

<u>Card</u>	<u>Columns</u>	<u>Variable name</u>	<u>Format</u>	<u>Comment</u>
-------------	----------------	----------------------	---------------	----------------

Card set 1: Plot and parameter card

1	10	IND	I1	IND = 1, plot in reverse direction only IND = 2, plot in forward direction only IND = 3, plot in both directions
---	----	-----	----	--

<u>Card</u>	<u>Columns</u>	<u>Variable name</u>	<u>Format</u>	<u>Comment</u>
1	20	FLAG	I1	FLAG = 1, least-squares fit to $p = at^{-1}$ and $p = bt^{-2}$ FLAG = 2, least-squares fit to $p = at^{-1} + bt^{-2}$ FLAG = 3, least-squares fit to all three equations
30		IPRAM	I1	IPRAM = 0, no item versus item plots IPRAM = 1, reverse direction item versus item plots only IPRAM = 2, forward direction item versus item plots only IPRAM = 3, forward and reverse direction item versus item plots only IPRAM = 4, forward and reverse direction item versus item plots and all curves as specified by IND and FLAG
40		ISTOP	I1	ISTOP = 1, tabular output only ISTOP = 2, tabular output and all output designated by IND, FLAG, and IPRAM ISTOP = 3, no tabular output, but all plots as indicated
49-50		IPLOT	I2	IPLOT = 0, plots come out on MDS system IPLOT = K, where $1 < K < 36$ indicates beam intensity of Cal Comp plotter; a good value is IPLOT = 18; plots come out at MERDC NOTE: ITYPE must be equal to 0.
60		ISEM	II	ISEM = 0, enter all input data in card sets 3 and 4 ISEM = 1, enter only pulse width versus power data on card set 5

<u>Card</u>	<u>Columns</u>	<u>Variable name</u>	<u>Format</u>	<u>Comment</u>
1	70	ITYPE	II	ITYPE = 0, regular Cal Comp plotting software is used ITYPE = 1, plotting software available on MDS remote batch terminal is used

Card set 2: Title card

2	1-3	NUMB	I3	If ISEM = 0 on card 1, NUMB is total number of devices If ISEM = 1 on card 1, NUMB is number of pulse width versus power points
---	-----	------	----	--

4-11	DEV	A8	Device name
------	-----	----	-------------

12-31	DEVTYP1, DEVTYP2	2A10	Device type
-------	------------------	------	-------------

32-40	JUNC	A9	Junction of device
-------	------	----	--------------------

41-60	MAN1, MAN2	2A10	Manufacturer of device
-------	------------	------	------------------------

61-70	TECH	A10	Technician
-------	------	-----	------------

71-80	DATEE	A10	Date
-------	-------	-----	------

NOTE: If ISEM = 1 on card 1,
skip to card set 5.

Card set 3: Pulse card

3	1-2	NPULS	I2	Total number of pulses for particular device number
3-80	-	-	-	Any comments or notations may be placed in these columns

NOTE: Card set 3 is repeated as many times as indicated on card set 2 for variable NUMB, and thus card set 4 is repeated this same number of times.

<u>Card</u>	<u>Columns</u>	<u>Variable name</u>	<u>Format</u>	<u>Comment</u>
Card set 4: Parameter value cards				
4	1-3	NDEV	I3	Device number; total number of repetitions of this card must not exceed 600
	4-5	PULSE	I2	Pulse number; not to exceed 99
	6-15	TDOC	E10.3	Pulse duration
	16-25	VOC	F10.3	Open-circuit voltage
	26-35	VP	F10.3	Peak voltage
	36-45	IP	F10.3	Peak current
	46-55	TD	E10.3	Failure time (TD ≠ 0)
	56-65	VZBP	F10.3	Voltage before forward breakdown voltage
5	1-10	VZAP	F10.3	Voltage after forward breakdown voltage
	11-20	VZBN	F10.3	Zener voltage before reverse breakdown voltage
	21-30	VZAN	F10.3	Zener voltage after reverse breakdown voltage
	31-40	GAINB	E10.3	Current gain before device was pulsed
	41-50	GAINA	E10.3	Current gain after device was pulsed
•	51-52	PIN	A2	Polarity of applied pulse: A+ = forward direction C+ = reverse direction
	53-71	REMAR1, REMAR2	A10,A9	Remarks

NOTE: Card set 4 represents data for one pulse and is repeated as many times as indicated on card set 3 for variable NPULS.

If ISEM = 0 on Card 1, data input is complete

<u>Card</u>	<u>Columns</u>	<u>Variable name</u>	<u>Format</u>	<u>Comment</u>
Card set 5: Pulse width and power cards				
6	1-20	IDENT1, IDENT2	2A10	Identification of data
	21-30	-	-	Blank
	31-40	XLAB	A10	Abscissa label
	41-50	-	-	Blank
	51-60	YLAB	A10	Ordinate label
7	1-10	T	E10.3	Pulse width
	11-20	PP	E10.3	Power
				NOTE: Data for pulse width versus power must be arranged in increasing order with respect to pulse width.
				Card 7 is repeated according to value NUMB appearing on Card 2

A sample listing of the input cards when ISEM = 0 on card set 1 is given in appendix D. Also, a sample listing of the input cards when ISEM = 1 on card set 1 is contained in appendix E.

9. CONTROL CARDS FOR RUNNING SEMCON

The SEMCON code is operational using the SCOPE 3.4.3 control language on the CDC 6600 computer at MERDC. Since several different plotting packages can be used, three distinct control card sets are required for the various options available. The following details the operation of the code.

If IPLOT = K where $1 \leq K \leq 36$ on card set 1 (plots come out at MERDC using the Cal Comp plotting software), then the control cards for running SEMCON are as follows:

```
EM ___ (MT1, T300)
TASK(TNEM ____, PW ____, TRTS) [user's name]
REQUEST, TAPE50, HI, VSN= ____, RING.
```

NOTE: VSN= ____ is the number of the blank tape at MERDC.

ATTACH,AGO,BINSEMCON,ID=EM71606.

ATTACH,F1,TALWYATT,ID=EM71602,MR=1.

LIBRARY(F1)

MAP(PART)

LDSET(PRESET=NGINF)

AGO.

TALPLOT(,TAPE1)

EXIT.

7/8/9

[Data]

0/6/7/8/9

If IPLOT = 0 and ITYPE = 0 on card set 1 (plots come out on the MDS system using the Cal Comp plotting software), then the control cards for running SEMCON are as follows:

EM_____(T300)

TASK(TNEM_____,PW_____,TRTS) [user's name]

ATTACH,AGO,BINSEMCON,ID=EM71606.

ATTACH,F1,TALWYATT,ID=EM71602,MR=1.

ATTACH,LIBA,ANAPAC,ID=EM71605,MR=1.

LIBRARY(F1,LIBA)

MAP(PART)

LDSET(PRESET=NGINF)

AGO.

TALPLOT(,TAPE1)

EXIT.

7/8/9

[Data]

0/6/7/8/9

If IPLOT = 0 and ITYPE = 1 on card set 1 (plots come out on the MDS system using the ANAPAC plotting software), then the control cards for running SEMCON are as follows:

EM ___ (T300)

TASK(TNEM _____, PW _____, TRTS) [user's name]

ATTACH,AGO,BINSEMCON,ID=EM71606.

ATTACH,LIBA,ANAPAC,ID=EM71605,MR=1.

LIBRARY(LIBA)

MAP(PART)

LDSET(PRESET=NGINF)

AGO.

EXIT.

7/8/9

[Data]

0/6/7/8/9

10. CONCLUSIONS

The SEMCON code has provided the means to analyze various semiconductor devices and, hence, assist in making EMP vulnerability assessments. The code has accomplished this objective by utilizing very straightforward techniques to calculate the least-squares fits for damage curves of semiconductor devices. For EMP efforts, the fits generated by SEMCON are considered to be reliable when good, accurate data are used. Also, the code has proven to be quite effective in tabulating and reducing numerous amounts of data. Thus, SEMCON is considered to be a useful code in semiconductor damage analysis and is written in such a way as to make it readily adaptable to numerous computer systems.

ABBREVIATIONS

E	Energy
FAIL	Failure
GAINA	Current gain after device was pulsed
GAINB	Current gain before device was pulsed
IP	Peak current
NDEV	Device number
P	Power
PIN	Polarity of applied pulse (i.e., reverse or forward direction)
PULSE	Pulse number
TD	Failure time
TDOC	Pulse duration
VOC	Open-circuit voltage
VP	Peak voltage
VZAN	Zener voltage after reverse breakdown voltage
VZAP	Voltage after forward breakdown voltage
VZBN	Zener voltage before reverse breakdown voltage
VZBP	Voltage before forward breakdown voltage
Z	Impedance

APPENDIX A.--SAMPLE PRODUCTION RUN OF SEMCON

This appendix contains examples of plots available through SEMCON and the computer center at the Mobility Equipment Research and Development Center, Fort Belvoir, VA.

DEVICE: IN3600 DEVICE TYPE: DIODE
MANUFACTURER: FAIRCHILD JUNCTION: C-A
TECHNICIAN: R.PARSONS DATE: 7-23-73

NO.	PT	T _{DC}	V _{DC}	V _P	IP	T _D	POWER	ENERGY IMPEDANCE	V _{ZB}	V _{ZA}	V _{ZB} *	V _{ZA} *	GAIN	GAIN	GAIN	PIN FAIL	REMARKS
1- 1	-	.10E-04	100.0	100.0	0.0	.10E-04	0.	.16E+02	0.	.16E+03	0.	.16E+03	1.0	1.0	1.0	0.0	0.0 C+ NC
1- 2	-	.10E-04	110.0	105.0	.2	.10E-04	.16E+02	.16E+03	.16E+03	.16E+03	.16E+03	.16E+03	1.0	1.0	1.0	0.0	0.0 C+ NC
1- 3	-	.10E-04	120.0	115.0	.6	.22E-05	.69E+02	.15E+03	.19E+03	.19E+03	.19E+03	.19E+03	1.0	0.0	0.0	0.0	0.0 C+ YES
2- 1	-	.10E-04	60.0	60.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
2- 2	-	.10E-04	70.0	70.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
2- 3	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
2- 4	-	.10E-04	90.0	90.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
2- 5	-	.10E-04	100.0	80.0	1.3	.20E-05	.10E+03	.21E+03	.61E+02	.61E+02	.61E+02	.61E+02	0.3	0.3	0.3	0.0	0.0 C+ NC
2- 6	-	.10E-04	110.0	90.0	2.2	.80E-06	.20E+03	.41E+02	.41E+02	.41E+02	.41E+02	.41E+02	0.3	0.3	0.3	0.0	0.0 C+ YES
3- 1	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
3- 2	-	.10E-04	90.0	90.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
3- 3	-	.10E-04	100.0	95.0	.7	.30E-05	.67E+02	.20E+03	.14E+03	.14E+03	.14E+03	.14E+03	0.3	0.0	0.0	0.0	0.0 C+ YES
4- 1	-	.10E-04	60.0	60.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
4- 2	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
4- 3	-	.10E-04	90.0	90.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
4- 4	-	.10E-04	110.0	105.0	1.0	.19E+05	.11E+03	.20E+03	.10E+03	.10E+03	.10E+03	.10E+03	0.3	0.0	0.0	0.0	0.0 C+ NC
5- 1	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
5- 2	-	.10E-04	90.0	85.0	.6	.12E-05	.51E+02	.61E+02	.14E+03	.14E+03	.14E+03	.14E+03	0.3	0.0	0.0	0.0	0.0 C+ NC
5- 3	-	.10E-04	100.0	90.0	1.4	.12E-05	.16E+03	.19E+03	.50E+02	.50E+02	.50E+02	.50E+02	0.3	0.0	0.0	0.0	0.0 C+ YES
6- 1	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
6- 2	-	.10E-04	90.0	90.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
6- 3	-	.10E-04	100.0	90.0	1.0	.12E-05	.90E+02	.90E+02	.90E+02	.90E+02	.90E+02	.90E+02	0.3	0.0	0.0	0.0	0.0 C+ YES
7- 1	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
7- 2	-	.10E-04	90.0	90.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
7- 3	-	.10E-04	100.0	95.0	.4	.27E-05	.38E+02	.10E+03	.24E+03	.24E+03	.24E+03	.24E+03	0.3	0.0	0.0	0.0	0.0 C+ NO
7- 4	-	.10E-04	100.0	90.0	1.2	.80E-06	.11E+03	.86E+04	.75E+02	.75E+02	.75E+02	.75E+02	0.3	0.0	0.0	0.0	0.0 C+ YES
8- 1	-	.10E-04	80.0	80.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
8- 2	-	.10E-04	90.0	90.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
8- 3	-	.10E-04	100.0	100.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
8- 4	-	.10E-04	110.0	110.0	0.0	.10E-04	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
8- 5	-	.10E-04	118.0	105.0	1.2	.10E-05	.13E+03	.13E+03	.87E+02	.87E+02	.87E+02	.87E+02	0.3	0.0	0.0	0.0	0.0 C+ YES
9- 1	-	.50E-05	80.0	80.0	0.0	.50E-05	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
9- 2	-	.50E-05	90.0	90.0	0.0	.50E-05	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
9- 3	-	.50E-05	100.0	95.0	.6	.28E-05	.57E+02	.16E+03	.16E+03	.16E+03	.16E+03	.16E+03	0.3	0.0	0.0	0.0	0.0 C+ NO
9- 4	-	.50E-05	112.0	100.0	.9	.90E-06	.90E+02	.81E+02	.11E+03	.11E+03	.11E+03	.11E+03	0.3	0.0	0.0	0.0	0.0 C+ YES
10- 1	-	.50E-05	80.0	80.0	0.0	.50E-05	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
10- 2	-	.50E-05	90.0	90.0	0.0	.50E-05	0.	0.	0.	0.	0.	0.	0.3	0.3	0.3	0.0	0.0 C+ NC
10- 3	-	.50E-05	100.0	97.0	.2	.11E-05	.19E+02	.21E+04	.48E+03	.48E+03	.48E+03	.48E+03	0.3	0.0	0.0	0.0	0.0 C+ NO
10- 4	-	.50E-05	110.0	103.0	.9	.18E-05	.93E+02	.11E+03	.11E+03	.11E+03	.11E+03	.11E+03	0.3	0.0	0.0	0.0	0.0 C+ YES

APPENDIX A

```
REVERSE FAILURE CURVES AND DATA FOR DEVICE IN3600

FITTING PARAMETER FOR P=A*t**(-1) IS: A= 1.40305738E-04
                                         OMEGA= 2.14102431E-02

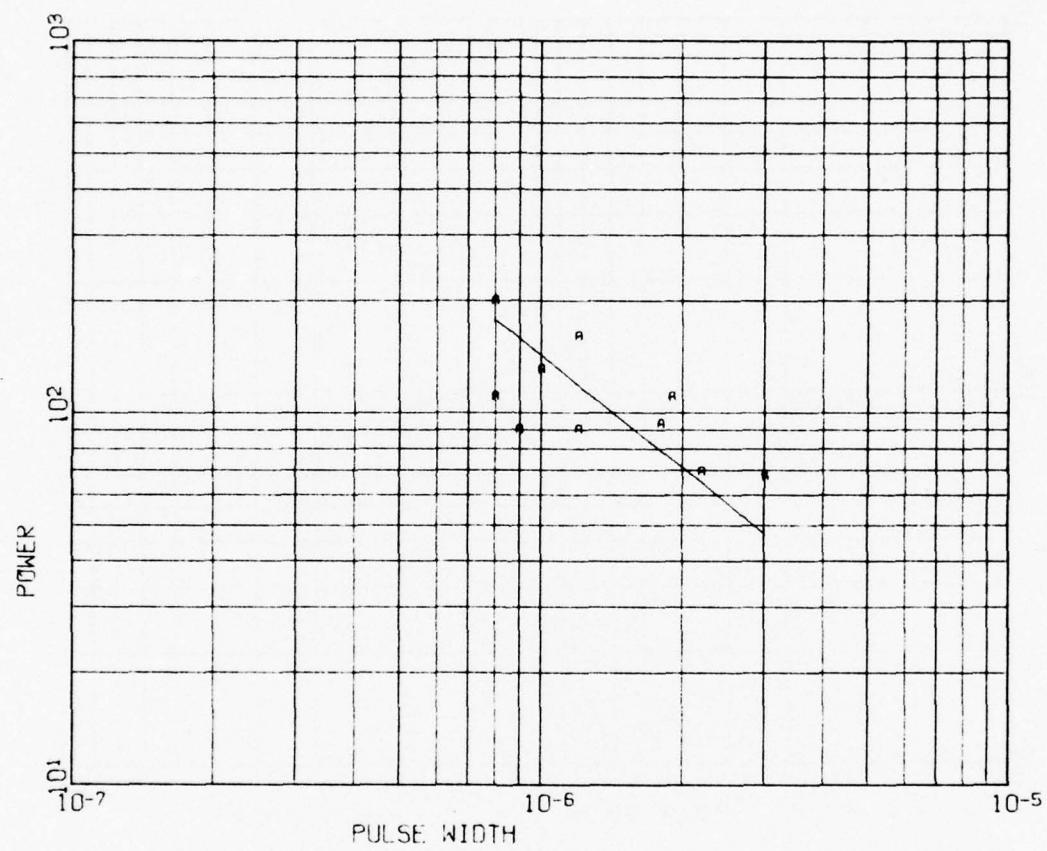
FITTING PARAMETER FOR P=B*t**(-.5) IS: B= 1.21107459E-01
                                         OMEGA= 1.19645330E-02

FITTING PARAMETERS FOR P=A*t**(-1)+B*t**(-.5) ARE: A= 3.35628819E-05
                                                    B= 9.28177482E-02
                                         OMEGA= 1.40030432E-02

A AND B FOUND IN 24 ITERATIONS   MINIMUM OF S(A,B)= 1.12024345E-01

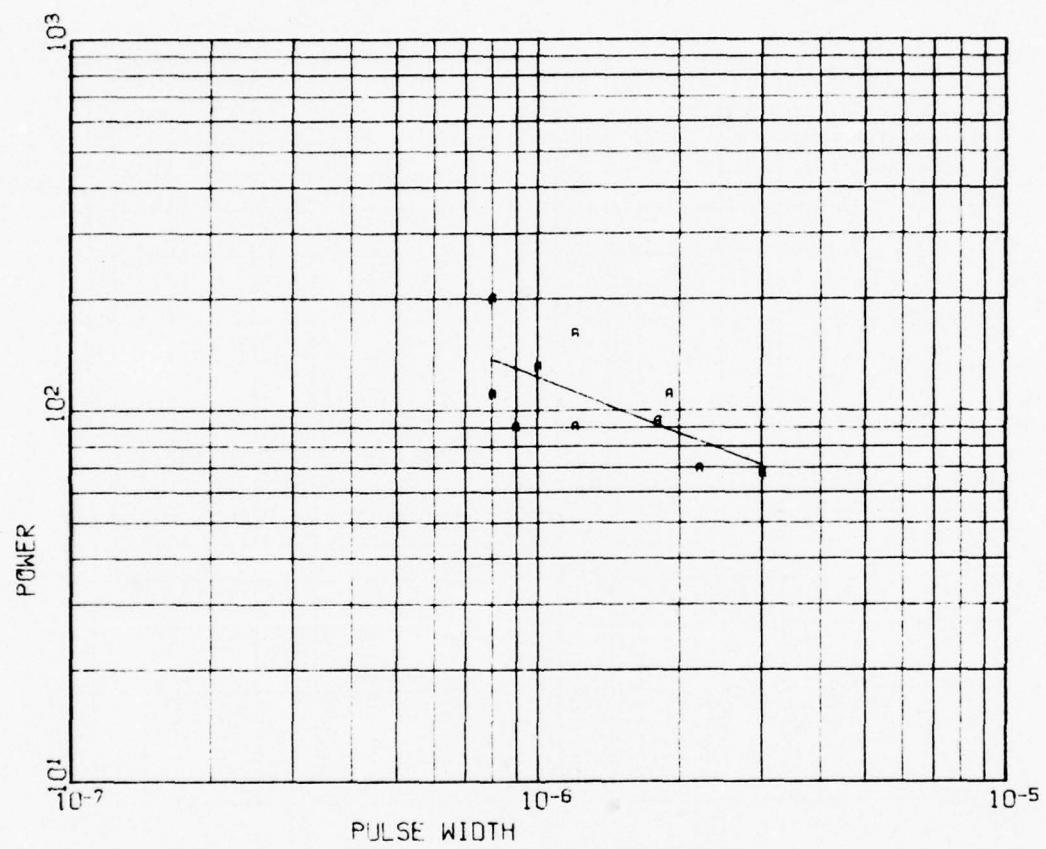
GAUSS CRITERION OF GOODNESS OF FIT
THE EQUATION WHICH BEST FITS THIS DATA IS:
P=B*t**(-.5)
```

APPENDIX A



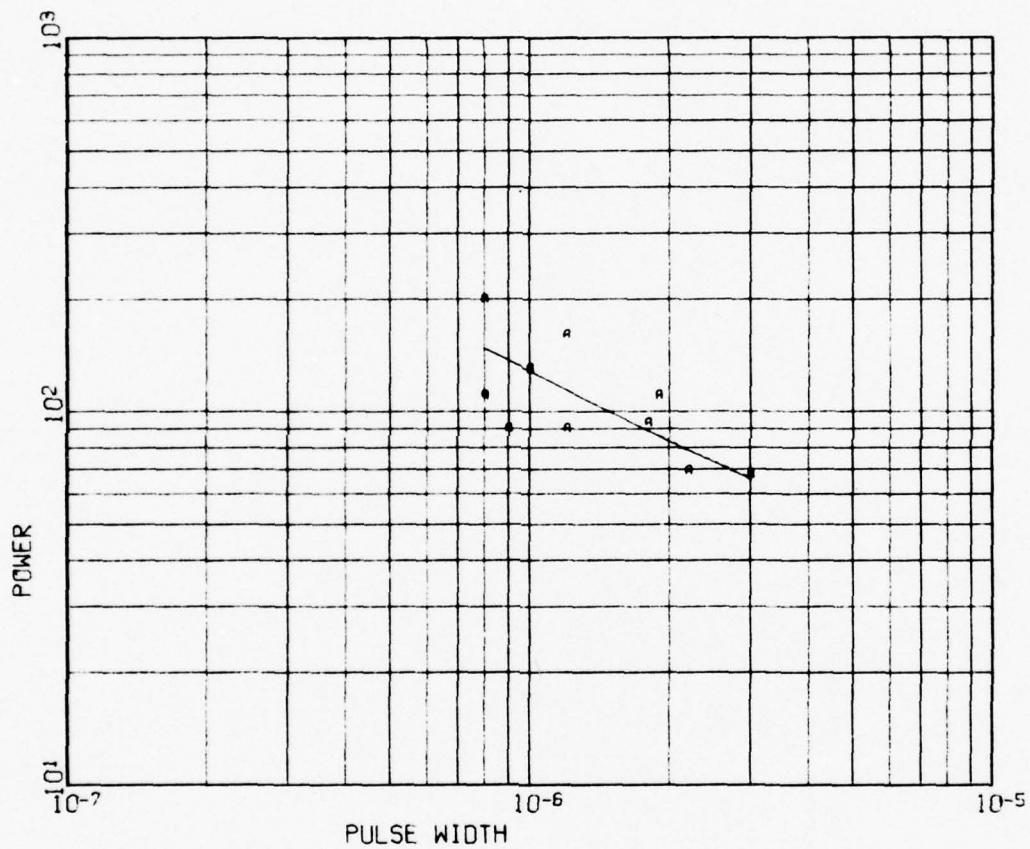
DEVICE: IN3600 REVERSE FAILURE
FIT TO $P = A \cdot T^{*-1}$

APPENDIX A



DEVICE: IN3600 REVERSE FAILURE
FIT 10 P=B*T**(-.5)

APPENDIX A



DEVICE: IN3600 REVERSE FAILURE
FIT TO $P = A * T^{(-1)} + B * T^{(-.5)}$

APPENDIX B.--SAMPLE PRODUCTION RUN OF SEMCON

This appendix contains examples of plots available through SEMCON
and the Mohawk Data Sciences computing system.

SEMI-CONDUCTOR DAMAGE PROGRAM - VERSION OF JUNE, 1975

06/10/76 11.58.41.

DEVICE: IN3600 DEVICE TYPE: DIODE
MANUFACTURER: FAIRCHILD JUNCTION: C-A
TECHNICIAN: R.PARSONS DATE: 7-23-73

IDENTIFICATION: REVERSE FAILURE

PULSE WIDTH	POWER	PULSE WIDTH	POWER
8.000E-07	1.000E+02	1.200E-06	9.000E+01
8.000E-07	2.000E+02	1.200E-06	1.600E+02
9.000E-07	9.000E+01	1.800E-06	9.300E+01
1.000E-06	1.300E+02		

REVERSE FAILURE CURVES AND DATA FOR DEVICE IN3600

FITTING PARAMETER FOR $P=A+Bt^{0.5}$ LS: A= 1.41779212E-04
B= 1.22460156E-01
DMEGA= 2.16628588E-02

FITTING PARAMETER FOR $P=Bt^{0.5}$ LS: B= 1.22460156E-01
DMEGA= 1.21928344E-02

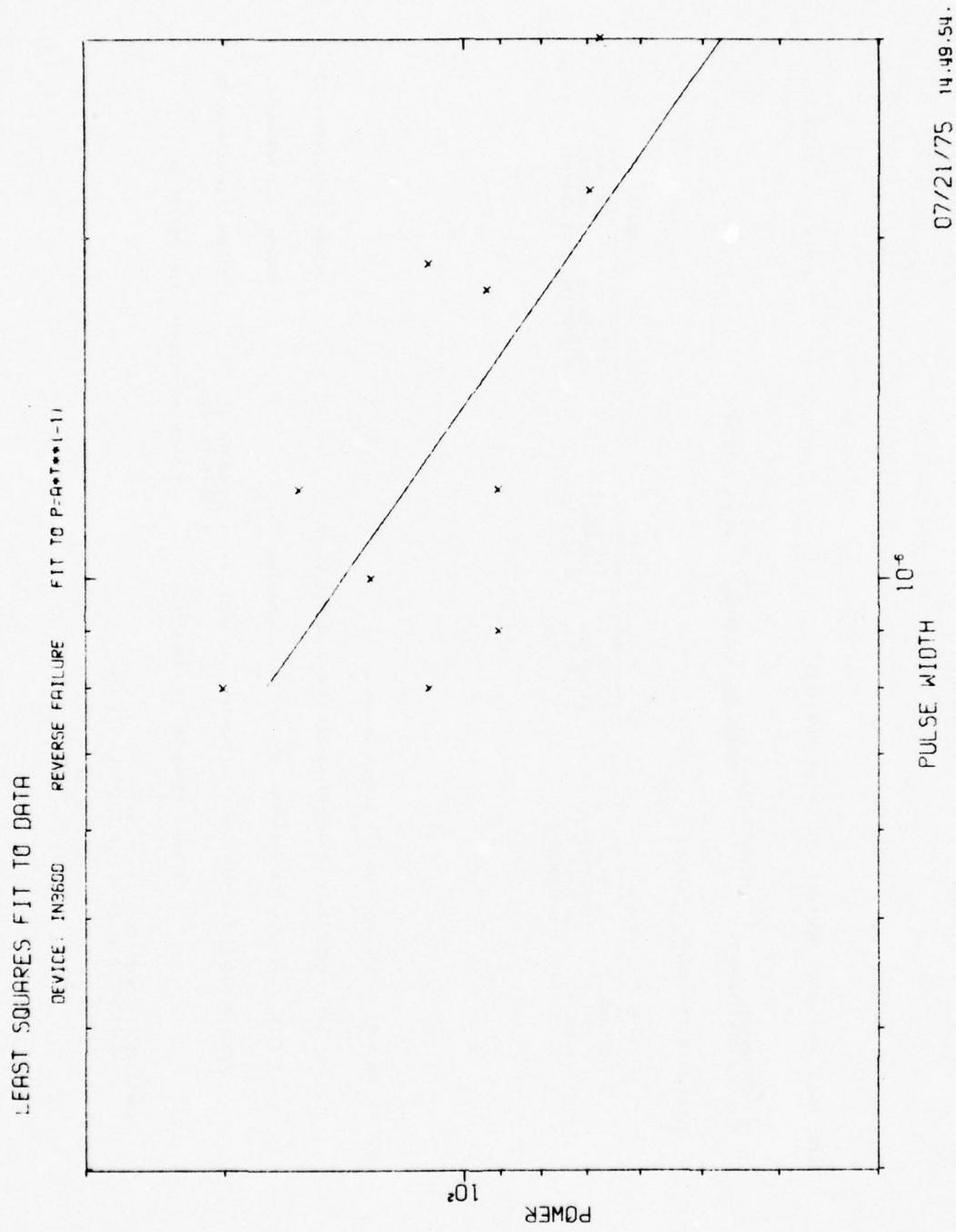
FITTING PARAMETERS FOR $P=A+Bt^{0.5}$ ARE: A= 3.39153554E-05
B= 9.37925093E-02
DMEGA= 1.42629648E-02

A AND B FOUND IN 24 ITERATIONS MINIMUM OF S(A,B)= 1.14103719E-01

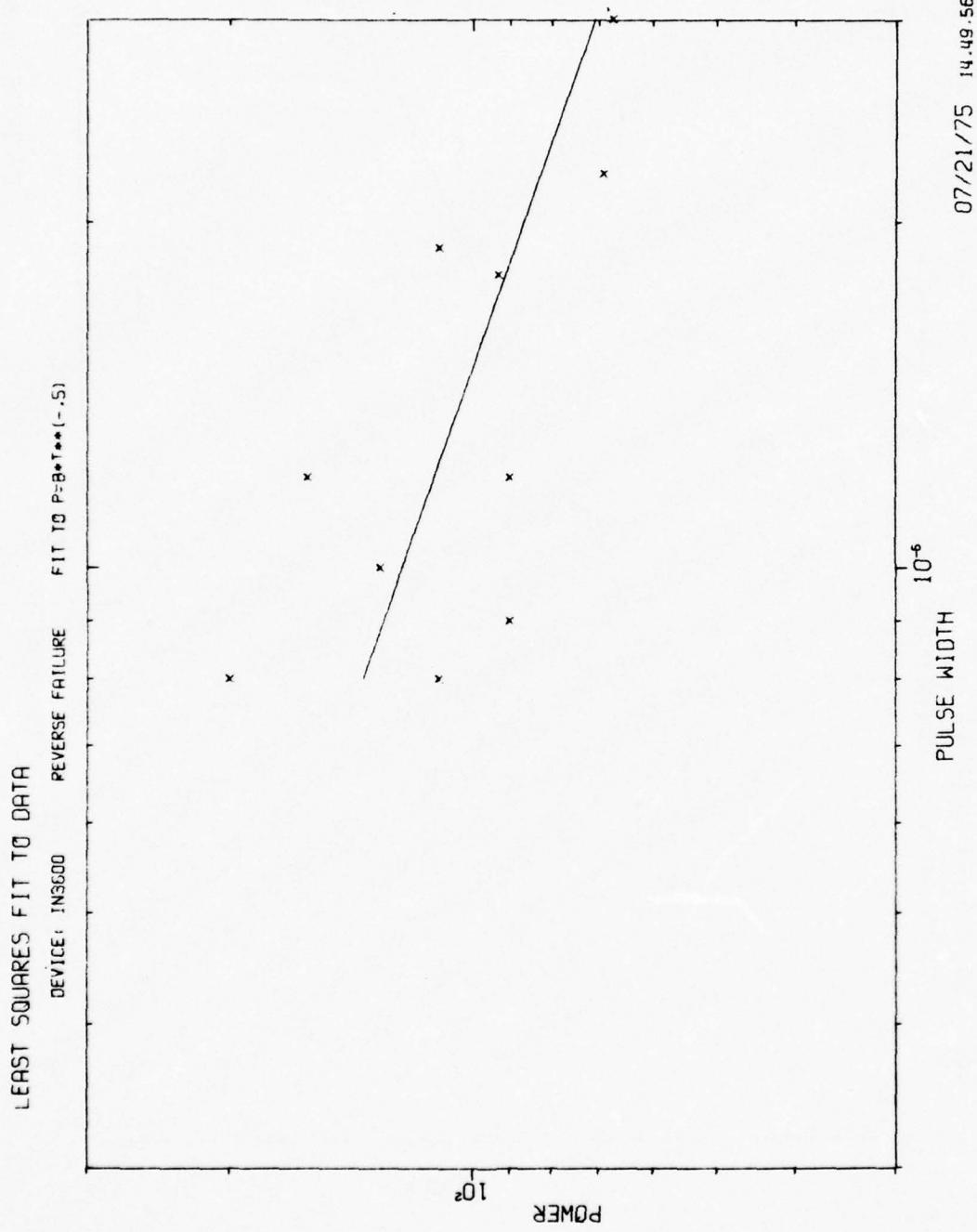
GAUSS CRITERION OF GOODNESS OF FIT
THE EQUATION WHICH BEST FITS THIS DATA IS:

 $P=Bt^{0.5}$

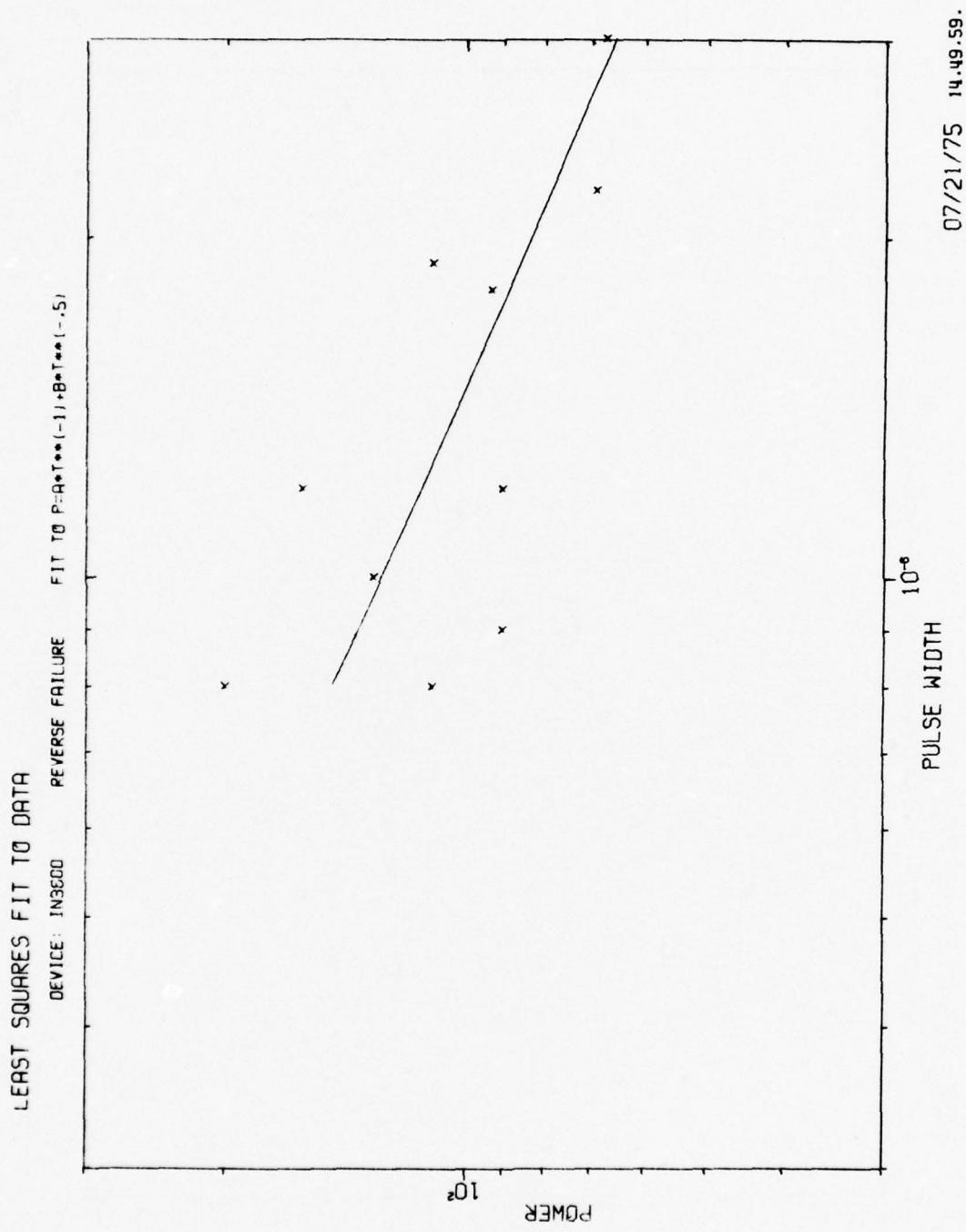
APPENDIX B



APPENDIX B



APPENDIX B



APPENDIX C.--LISTING OF SEMCON

This appendix contains a complete listing of SEMCON.

```

PROGRAM SEMCON      76/74   OPT=1           FIN 4.5+414      06/01/76  14.04.49   PAGE 1
1          PROGRAM SEMCON(INPUT,OUTPUT,TAPES=INPUT,TAPE6=OUTPUT,TAPE1,TAPE7)    SEMCON
2          SEMCON 2
3          SEMCON 3
4          SEMCON 4
5          SEMCON 5
6          SEMCON 6
7          SEMCON 7
8          SEMCON 8
9          SEMCON 9
10         SEMCON 10
11         SEMCON 11
12         SEMCON 12
13         SEMCON 13
14         SEMCON 14
15         SEMCON 15
16         SEMCON 16
17         SEMCON 17
18         SEMCON 18
19         SEMCON 19
20         SEMCON 20
21         SEMCON 21
22         SEMCON 22
23         SEMCON 23
24         SEMCON 24
25         SEMCON 25
26         SEMCON 26
27         SEMCON 27
28         SEMCON 28
29         SEMCON 29
30         SEMCON 30
31         SEMCON 31
32         SEMCON 32
33         SEMCON 33
34         SEMCON 34
35         SEMCON 35
36         SEMCON 36
37         SEMCON 37
38         SEMCON 38
39         SEMCON 39
40         SEMCON 40
41         SEMCON 41
42         SEMCON 42
43         SEMCON 43
44         SEMCON 44
45         SEMCON 45
46         SEMCON 46
47         SEMCON 47
48         SEMCON 48
49         SEMCON 49
50         SEMCON 50
51         SEMCON 51
52         SEMCON 52
53         SEMCON 53
54         SEMCON 54
55         SEMCON 55
56         SEMCON 56
57         SEMCON 57
58         SEMCON 58

        INTEGER FLAG,FAIL,PULSE
        REAL IP,JUNC,MAN1,MAN2
        REAL IPFF,IP
        COMMON/PUNC/FLAG,IPRAM2/
        COMMON/PIN(600)/P(600),T(600),E(600),TDC(600),Z(600),VOC(600) .
1        IPFLAG,FAIL(600)
        COMMON/A/IND,FLAG,IPRAM,DEV
        COMMON/B/PRF(600),TDF(600),ERF(600),TDDCRF(600),ZRF(600) .
1        VDRF(600),IPRF(600),IP(600),P1(600),P2(600),P3(600)
        COMMON/C/PFF(600),TDF(600),FF(600),TDDCF(600),ZFF(600) .
1        VOCF(600),IPFF(600)
        COMMON/D/T1600/PP(600)
        COMMON/E/GAUS(3),S
        COMMON/F/IPLOT,ISEM,ITYPE
        COMMON/G/DEVTYPE1,DEVTYPE2,JUNC,MAN1,MAN2,TECH,DATE,LISTOP
        DIMENSION NPULS(300),VP(1600),VZP(600),VAP(600),VZN(600),
1        REMAR1(600),REMAR2(1600),REMAR2(600),GAINB(600),
2        GAINA(600),MDEV(600),PULSE(600)

        PRINT 10
10       FORMAT(1H1)
        CALL DATE(DAT)
        CALL TIME(TIM)
        PRINT 20, DAT,TIM
20       FORMAT(1X,44H SEMI-CONDUCTOR DAMAGE PROGRAM - VERSION OF ,
112H JUNE 1975,32X,A10.5X,A10.5X,A10.5X,A10.5X,A10.5X,A10.5X)
        READ(5,25) IND,FLAG,IPRAM,LISTOP,IPLOT,ISEM,ITYPE
25       FORMAT(49X,11.8X,12.219X,11)
        READ(5,30) NUMB,DEV,DEVTYPE1,DEVTYPE2,JUNC,MAN1,MAN2,TECH,DATE
30       FCKRAT(13,AB,2A10,AB,4A10)
        IF(LISTOP,NE-1) WRITE(6,33)
33       FORMAT(17HMP THIS JOB PLUTS)
        IF(ISEM,EQ,0) GO TO 35
        CALL DMDAT(NUMB)
        GO TO 210
35       L=0
        DC 70  I=1,NUMB
        READ(5,40) NPULS(1)
40       FORMAT(12)
        NPUL=NPULS(1)
        DO 70  J=1
        L=L+1
        READ(5,50) MDEV(L),PULSE(L),TDC(L),VCC(L),VP(L),IP(L),
1        ITD(L),VZP(L)
        FORMAT(13,12,E10.3,F10.3,F10.3,E10.3,F10.3)
        READ(5,60) VZAP(L),VZN(L),VAP(L),GAINA(L),GAINB(L),PIN(L),
1        REMAR1(L),REMAR2(L)
        FORMAT(3F10.3,2(2PF10.2),A2,A10,A9)
        CONTINUE
70

        NUM=1
        DO 90  K=1,NUM
        P(K)=0.
        E(K)=0.

        PRECEDING PAGE BLANK-NOT FILMED

```

APPENDIX C

PROGRAM SEMCON	74/74	OPT=1	FTN 4.5+4.14	06/01/76	14.04.49	PAGE
Z(K)=0.						
60			IF(I.P(K).LE.0) GO TO 80			
			IF(V.P(K).LE.0) GO TO 80			
			P(K)=V(P(K))&P(K)			
			E(K)=P(K)&TOK(K)			
			2(K)=V(P(K))-V2B(P(K))/IP(K)			
65			IF(Z(K).LT.-0.1) Z(K)=0.			
			CALL FAILUR(VZBPK(K),V_ZAP(K),FAIL(K))			
			IF(FAIL(K).EQ.3HYES) GO TO 90			
			CALL FAILUR(VZBALK(V_ZAN(K)),FAIL(K))			
			IF(FAIL(K).EQ.3HYES) GO TO 90			
			CALL FAILUR(GAINB(K),GAINA(K),FAIL(K))			
70			CONTINUE			
			IF(LISTOP.EQ.3) GC TO 145			
			PRINT 100,DEV,DEVTYPE2,JUNG,MAN1,MAN2,TECH,DATE			
75			110 FORMAT(1X,<BH>DEVICE:,A40,3X,13HDEVICE TYPE:,2A10,3X,			
			2A10,3X,6HDATE:,A10,/,/)			
			PRINT 110			
			110 FORMAT(1X,3HNO.,1X,2HPT,3X,4HTDC,6X,3HVOC,6X,2HVP,6X,			
			12HID,6X,5HPOWER,3X,6HENERGY,1X,9HIMPEDANCE,2X,6HVZD+,2X,6MHzA+,			
			22X,4HVBZB+,2X,4HVA+,2X,5HGAINB,1X,5HGAINA,1X,3HPIN,1X,4HFAIL,5X,			
			3HREMARKS)			
c0			PRINT 120			
			120 FORMAT(1X,3H---,1X,2H---,3X,4H---,6X,3H---,4X,2H---,4X,2H---,5X,			
			12H---,6X,5H---,3X,6H---,2X,4H---,2X,4H---,2X,4H---,2X,4H---,2X,			
			22X,4H---,2X,4H---,2X,5H---,1X,5H---,1X,3H---,1X,4H---,1X,			
c5			37H---,1			
			L=0			
			DC 140 I=1,NURB			
			NPUL,NPULS()			
			DC 140 J=1,NPUL			
90			L=L+1			
			PRINT 130,INDEX(L),PULSE(L),TDC(L),VOC(L),VPL(L),P(L),TD(L),P(L),			
			1E(L),Z(L),VZP(L),V_ZAP(L),VZB(L),VZAN(L),GAINB(L),GAINA(L),			
			2PIN(L),FAIL(L),REMAR(L),REMAR2(L)			
95			130 FORMAT(1H,13,1H-,12,1X,F8-.2JX,F6-.1JX,F6-.1JX,F5-.1JX,E6-.2,			
			2F6-.2JX,F5-.1JX,A2,1X,A3,1X,A10,19)			
			140 CONTINUE			
			IF(LISTOP.EQ.1) GO TO 210			
			145 CONTINUE			
100			PRINT 150			
			150 FORMAT(1H)			
			CALL FRATELNUM,KNUM,JNUM			
			1F1PROM-EQ.6) GO TO 160			
			1F1PROM,NE,0) GO TO 200			
105			160 GC TO 1170,180,170,1,IND			
			170 CALL DIRECT(KNUM,1,A,B,AE,BE,IT)			
			CALL WRITEA,B,AE,BE,1,IT)			
			CALL GAUSS			
			CALL PLOTTKNUM,JNUM,1)			
			1F1INC-EQ.-1) GC TO 190			
110			18C IF(JNUM.EQ.0) GO TO 190			
			CALL DIRECT(JNUM,2,A,BAE,BE,IT)			
			CALL WRITEA,B,AE,BE,2,IT)			
			CALL GAUSS			
			SEMCON 59			
			SEMCON 60			
			SEMCON 61			
			SEMCON 62			
			SEMCON 63			
			SEMCON 64			
			SEMCON 65			
			SEMCON 66			
			SEMCON 67			
			SEMCON 68			
			SEMCON 69			
			SEMCON 70			
			SEMCON 71			
			SEMCON 72			
			SEMCON 73			
			SEMCON 74			
			SEMCON 75			
			SEMCON 76			
			SEMCON 77			
			SEMCON 78			
			SEMCON 79			
			SEMCON 80			
			SEMCON 81			
			SEMCON 82			
			SEMCON 83			
			SEMCON 84			
			SEMCON 85			
			SEMCON 86			
			SEMCON 87			
			SEMCON 88			
			SEMCON 89			
			SEMCON 90			
			SEMCON 91			
			SEMCON 92			
			SEMCON 93			
			SEMCON 94			
			SEMCON 95			
			SEMCON 96			
			SEMCON 97			
			SEMCON 98			
			SEMCON 99			
			SEMCON 100			
			SEMCON 101			
			SEMCON 102			
			SEMCON 103			
			SEMCON 104			
			SEMCON 105			
			SEMCON 106			
			SEMCON 107			
			SEMCON 108			
			SEMCON 109			
			SEMCON 110			
			SEMCON 111			
			SEMCON 112			
			SEMCON 113			
			SEMCON 114			
			SEMCON 115			

PROGRAM SENCON	74/74	OPT=1	FTN 4.5+14	06/01/76	14.04.49	PAGE
115	CALL PLOTT(KNUM,JNUM,2)					3
190	CONTINUE					
1	I(IPRAM,EQ,0) GO TO 210					
200	CALL PLOTT(KNUM,JNUM,3)					
210	STOP					
120	END					

CARD NR. SEVERITY DETAILS DIAGNOSIS OF PROBLEM
 105 1 AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES	RELOCATION	REFS	106	107	112	113
10215 SENCON	1			REFS	106	107	112	113
VARIABLES	SN	TYPE		REFS	106	107	112	113
11153 A	REAL			REFS	106	107	112	113
11155 AF	REAL			REFS	106	107	112	113
11154 B	REAL			REFS	106	107	112	113
11156 BE	REAL			REFS	106	107	112	113
11140 DAT	REAL			REFS	26	28		
6 DATEE	REAL			REFS	20	72	DEFINED	33
3 DEV	REAL	A		REFS	12	72	DEFINED	33
0 DEVTYPE1	REAL	C		REFS	20	72	DEFINED	33
1 DEVTYPE2	REAL	C	/	REFS	20	72	DEFINED	33
3410 E	REAL	ARRAY		REFS	10	91	DEFINED	57
2260 EFF	REAL	ARRAY	C	REFS	15			62
2260 ERF	REAL	ARRAY	B	REFS	13			
11300 FAIL	INTEGER	ARRAY	/	REFS	7	10	65	66
1 FLAG	INTEGER	A		REFS	91			68
24264 GAINA	REAL	ARRAY		REFS	7	12	DEFINED	31
23134 GAINB	REAL	ARRAY		REFS	21	69	91	DEFINED
0 GAUS	REAL	ARRAY	E	REFS	21	69	91	DEFINED
11166 I IND	INTEGER	INTEGER	A	REFS	18			
10150 I P	REAL	ARRAY	/	REFS	42	66	88	DEFINED
7020 IPFF	REAL	ARRAY	C	REFS	12	105	110	DEFINED
0 IPLOT	INTEGER	F		REFS	8	10	59	61
2 IPRAM	INTEGER	A		REFS	67			
7020 IPFF	REAL	ARRAY	B	REFS	19	15		
1 ISEM	INTEGER	F		REFS	12	103	104	DEFINED
7 ISTOP	INTEGER	C		REFS	9	13		
11157 IT	INTEGER	INTEGER		REFS	19	37		
2 ITYPE	INTEGER	F		REFS	20	35	71	DEFINED
11146 J	INTEGER			REFS	106	107	112	113
11152 JNUM	INTEGER			REFS	19	DEFINED	31	
2 JUNC	REAL	C		REFS	45	89	109	111
				REFS	102	109	111	112
				REFS	8	20	72	DEFINED
				REFS				33

APPENDIX C

PROGRAM SECTION	74/74	OPT=1	RELOCATION		FTN 4.5+4.9	06/01/76	14.04.49	PAGE	4
VARIABLES	SN	TYPE			REFS	56	58	59	60
11150 K		INTEGER			4 _{b3}	2 _{b4}	6 _{b5}	6 _{b6}	3 _{b1}
11151 KNUM		INTEGER			DEFINED	55	66	3 _{b7}	3 _{b9}
11143 L		INTEGER			REFS	102	106	115	118
3 MAN1	REAL		G		REFS	46	8 _{b4} 7	8 _{b5} 0	90
4 MAN2	REAL		G		REFS	40	46	86	90
25414 NDEV	INTEGER		ARRAY		REFS	8	20	72	DEFINED
11145 NPUL	INTEGER		ARRAY		REFS	21	91	DEFINED	33
12230 YPULS	INTEGER		ARRAY		REFS	45	89	DEFINED	47
11147 NUM	INTEGER		ARRAY		REFS	21	44	88	88
11142 NMB	INTEGER		ARRAY	/ /	REFS	55	102	DEFINED	42
11130 P	REAL		ARRAY	C	REFS	38	41	87	54
0 PFF	REAL		ARRAY	/ /	REFS	10	62	91	DEFINED
0 PIN	REAL		ARRAY	D	REFS	15	10	91	DEFINED
11130 PP	REAL		ARRAY	B	REFS	17	13	91	50
11160 PRF	REAL		ARRAY	B	REFS	13	7	21	91
11160 PULSE	INTEGER		ARRAY		REFS	7	21	91	DEFINED
10150 P1	REAL		ARRAY	B	REFS	13			47
11300 P2	REAL		ARRAY	B	REFS	13			
12430 P3	REAL		ARRAY	B	REFS	13			
20654 REMAR1	REAL		ARRAY	B	REFS	21	91	DEFINED	50
22004 REMAR2	REAL		ARRAY	B	REFS	21	91	DEFINED	50
3 S	REAL		E		REFS	18			
0 T	REAL		ARRAY	D	REFS	17			
2260 TD	REAL		ARRAY	/ /	REFS	10	62	91	DEFINED
1130 TDF	REAL		ARRAY	C	REFS	15			47
4540 TDOC	REAL		ARRAY	/ /	REFS	10	91	DEFINED	47
3410 TDOCF	REAL		ARRAY	C	REFS	15			
3410 TDOCRF	REAL		ARRAY	B	REFS	13			
1130 TDRF	REAL		ARRAY	B	REFS	13			
5 TECH	REAL		C		REFS	20	72	DEFINED	33
11141 TIM	REAL				REFS	27	28		
7020 VOC	REAL		ARRAY	/ /	REFS	10	91	DEFINED	47
5670 VOCFF	REAL		ARRAY	C	REFS	15			
5670 VOCRF	REAL		ARRAY	B	REFS	13			
12784 VP	REAL				REFS	21	60	61	63
FILE NAMES		MODE			DEFINED	47			91
0 INPUT					REFS	21	67	91	DEFINED
2061 OUTPUT	FMT				REFS	21	65	91	50
4102 TAPE1					REFS	21	67	91	DEFINED
0 TAPE5	FMT				REFS	21	63	91	50
2041 TAPE6	FMT				REFS	10	64	91	DEFINED
6163 TAPE7					REFS	13			64
		WRITES				24	28	72	76
		READS				31	33	42	47
		WRITES				35			50
									100

PROGRAM	SENCUN	74/74	OPT=1	FTN 4.54414	06/01/76	14.04.49	PAGE
EXTERNALS	TYPE	ARGS	REFERENCES				5
DIRECT		1	26				
DATE	FMT	7	106	112			
FAILURE	FMT	3	65	67	69		
ERFAIL	FMT	3	102				
GAUSS	FMT	0	108	114			
DNDAAT	FMT	1	38				
PLOTT	FMT	3	109	115			
TIME	FMT	1	27				
WRITE	FMT	6	107	113			
STATEMENT LABELS							
10621	LJ	FMT	25	24			
10620	20	FMT	29	28			
10625	25	FMT	32	31			
10676	30	FMT	34	33			
10704	33	FMT	36	35			
10742	35	FMT	40	37			
10715	40	FMT	43	42			
10733	50	FMT	49	47			
10755	60	FMT	52	50			
10756	70	FMT	53	51	45		
10736	80	FMT	65	59	60		
10761	90	FMT	70	55	66	68	
10774	100	FMT	73	72			
11014	110	FMT	77	76			
11040	120	FMT	82	81			
11110	130	FMT	94	91			
10450	140	FMT	97	87	89		
10452	145	FMT	99	71			
11131	150	FMT	101	100			
10461	160	FMT	105	103			
10471	170	FMT	106	2*105			
10502	180	FMT	111	105			
10512	190	FMT	116	110	111		
10513	200	FMT	118	104			
10515	210	FMT	119	39	98	117	
LOOPS	LABEL	INDEX	FROM-TO	LENGTH	PROPERTIES		
10244	70	* I	42 53	558	EXT REFS	NOT INNER	
10254	70	* J	45 53	436	EXT REFS		
10324	30	* K	55 70	408	EXT REFS		
10375	140	* I	87 97	538	EXT REFS	NOT INNER	
10400	140	* J	89 97	468	EXT REFS		
COMMON BLOCKS LENGTH MEMBERS - BIAS NAME (LENGTH)							
/	54.00	0 PIN	(600)	600	P	(600)	
A	4	1800 F	(600)	2400	TDC	(600)	
B	6.000	3600 VDC	(600)	4200	IP	(600)	
C	4.200	0 IND	(1)	1	FLAG	(1)	
		3 DEV	(1)	2	IPRAN	(1)	
		0 PRF	(600)	600	TDRF	(600)	
		1800 TDRCF	(600)	2400	ZRF	(600)	
		3600 IPRF	(600)	4200	P1	(600)	
		5400 P3	(600)	4800	P2	(600)	
		0 PFF	(600)	600	TOFF	(600)	
		1800 TDOCFF	(600)	2400	ZFFF	(600)	
		3600 IPFF	(600)	3050	VDCFF	(600)	

APPENDIX C

PROGRAM SECTION	74/74	OPT=1		FTN 4.5+4.14	02/01/76	14.04.49	PAGE
COMMON BLOCKS	LENGTH	MEMBERS - BIAS NAME(LENGTH)					6
D	1200	0 T (600)		600 PP (600)			
E	4	0 GAUS (3)		3 S (1)			
F	3	0 IPLOT (1)		1 ISEM (1)		2 ITYPE (1)	
G	8	0 DEVTYPE(1)		1 DEVTYPE2(1)		2 JUNC (1)	
		3 MAN1 (1)		4 MAN2 (1)		5 TECH (1)	
		6 DATEEE (1)		7 ISTCP (1)			
STATISTICS							
PROGRAM LENGTH	163378	7391					
BUFFER LENGTH	102058	4229					
CM LABELED COMMON LENGTH	263338	11419					
CM BLANK COMMON LENGTH	124308	5400					

APPENDIX C

	SUBROUTINE FAILUR	74/74	(OPT=1)	FTN 4.5+614	06/01/76	14.04.49	PAGE	1
1	SUBROUTINE FAILUR (R,S,N)			FAILUR	2			
	REAL N			FAILUR	3			
	N=3H NO			FAILUR	4			
	IF(R.LE.0.) RETURN			FAILUR	5			
	IF(.59R-S.GT.-C.) N=3H YES			FAILUR	6			
5	RETURN			FAILUR	7			
	END			FAILUR	8			

SYMBOLIC REFERENCE MAP (NR=3)

ENTRY POINTS	DEF LINE	REF LINE	REFERENCES	RELATION	REFS	REFS	REFS	DEFINED	DEFINED	DEFINED	DEFINED
3 FAILUR	1	4	6	REAL	F.P.	F.P.	F.P.	1	1	1	1
VARIABLES	SN	TYPE									
0 N		REAL									
0 R		REAL									
0 S		REAL									
STATISTICS				PROGRAM LENGTH	20B	16					

APPENDIX C

SYNTHETIC BEEFSTEAK

ENTRY POINTS	DEF LINE	REFERENCES
3 FFAIL	1	38
VARIABLES	SN	TYPE
3410 F		REAL
286 C		REAL
2260 ERF		REAL
111100 FAIL		REAL
65 I		INTEGER
		RELOCATION
	/	ARRAY
	/	ARRAY
	C	ARRAY
	B	ARRAY
	/	ARRAY

APPENDIX C

SUBROUTINE FRFAIL		74/74	OPT=1	FTN 4.5+6.14	06/01/76	14.04.49	PAGE	2
VARIABLES	SN TYPE	RELATION						
10150 1P	REAL	ARRAY /	REFS	3	4	22	31	
7020 1PF	REAL	ARRAY C	REFS	2	6	DEFINED	31	
7020 1PRF	REAL	ARRAY B	REFS	2	6	DEFINED	22	
64 J	INTEGER		REFS	26	27	28	29	32
0 JNUM	INTEGER		DEFINED	33	37	DEFINED	11	33
63 K	INTEGER		REFS	1	37	19	20	22
0 KNUM	INTEGER	F.P.	DEFINED	17	18	19	20	23
0 NUM	INTEGER	F.P.	REFS	1	36	DEFINED	10	24
1130 P	REAL	ARRAY /	REFS	12	DEFINED	1	36	
0 PFF	REAL	ARRAY C	REFS	4	DEFINED	1	18	
0 PIN	REAL	ARRAY /	REFS	4	DEFINED	18	27	
0 PRF	REAL	ARRAY B	REFS	8	DEFINED	27		
10150 P1	REAL	ARRAY B	REFS	4	14	15	15	
1130 P2	REAL	ARRAY B	REFS	6	DEFINED	18		
12430 P3	REAL	ARRAY B	REFS	6	DEFINED	18		
2260 TC	REAL	ARRAY /	REFS	6	DEFINED	18		
1130 TDF	REAL	ARRAY C	REFS	6	DEFINED	26	26	
4540 TDC	REAL	ARRAY /	REFS	6	DEFINED	23	32	
3410 TDQFF	REAL	ARRAY C	REFS	6	DEFINED	32		
3410 TDQRF	REAL	ARRAY B	REFS	6	DEFINED	23		
1130 TDRF	REAL	ARRAY B	REFS	6	DEFINED	17		
1130 VDR	REAL	ARRAY /	REFS	4	DEFINED	21	30	
7020 VJC	REAL	ARRAY C	REFS	6	DEFINED	30		
5670 VDFF	REAL	ARRAY B	REFS	6	DEFINED	21		
5670 VDRF	REAL	ARRAY /	REFS	4	DEFINED	21		
5670 Z	REAL	ARRAY C	REFS	8	DEFINED	20	29	
4540 ZFF	REAL	ARRAY B	REFS	6	DEFINED	29		
4540 ZRF	REAL	ARRAY B	REFS	6	DEFINED	20		
STATEMENT LABELS		DEF LINE REFERENCES						
22 10		17 14						
35 20		26 15						
50 30		35 12						
LOOPS LABEL INDEX		FROM-TO LENGTH PROPERTIES						
14 30 I		12 35 35B OPT						
COMMON BLOCKS LENGTH MEMBERS - BIAS NAME LENGTH								
/ / 5400 0 PIN (600)		600 P (600)						
		1800 E (600)						
		3600 VJC (600)						
B 6000		3600 PRF (600)						
		1800 TDQRF (600)						
		3600 IPRF (600)						
		5400 P3 (600)						
C 4200		5400 PF (600)						
		1800 TDQFF (600)						
		3600 IPFF (600)						
STATISTICS								
PROGRAM LENGTH		666 54						
IN LABELED COMMON LENGTH		237308 10200						
IN BLANK COMMON LENGTH		124308 5400						

APPENDIX C

SUBROUTINE	DIRECT	74/74	GPT=1	FIN 4.5+614	PAGE	1
1	SUBROUTINE DIRECT (N,M,A,B,AE,BE,I1)				DIRECT	2
	INTEGER FLAG				DIRECT	3
	REAL IPFF,IPRF				DIRECT	4
	COMMON/A/IND,FLAG,IPRM,DEV				DIRECT	5
	COMMON/B/PRF(600),TRF(600),ERF(600),TDOC(RF(600),2RF(600),				DIRECT	6
5	VOCR(600),JPREF(600),P1(600),P2(600),P3(600)				DIRECT	7
	COMMON/C/PFF(600),TOFF(600),EFF(600),TDOC(CFF(600),2FF(600),				DIRECT	8
	VOCF(600),IPFF(600)				DIRECT	9
1	COMMON/D/T(600),PP(600)				DIRECT	10
10	J=1				DIRECT	11
	K=1				DIRECT	12
	GC TO 110,30,551,M				DIRECT	13
10	DO 20 I=1,N				DIRECT	14
	IF(IPRF(I).EQ.0.) GO TO 15				DIRECT	15
15	T(I)=TRF(I)				DIRECT	16
	PP(J)=PRF(I)				DIRECT	17
	J=J+1				DIRECT	18
15	IF(I1.EQ.N.AND.PRF(I1).EQ.0.) J=J+1				DIRECT	19
20	CONTINUE				DIRECT	20
20	N=J-1				DIRECT	21
	GO TO 50				DIRECT	22
30	DC 40 I=1,N				DIRECT	23
	IF(PFF(I).EQ.0.) GO TO 35				DIRECT	24
	T(K)=TDF(I)				DIRECT	25
	PP(K)=PFF(I)				DIRECT	26
35	K=K+1				DIRECT	27
	IF(I1.EQ.N.AND.PFF(I1).EQ.0.) K=K+1				DIRECT	28
40	CNTINUE				DIRECT	29
	N=K-1				DIRECT	30
30	CALL SORT (N)				DIRECT	31
	GO TO 60,70,601,FLAG				DIRECT	32
50	CALL ALSQRIN,A,				DIRECT	33
	CALL GOODFITPP,P2,N,1,1)				DIRECT	34
	CALL BLQRIN,B,				DIRECT	35
	CALL GOODFITPP,P3,N,1,2)				DIRECT	36
35	IF(FLAG.EQ.1) GO TO 80				DIRECT	37
	IIF(IFLAG.EQ.3) GO TO 75				DIRECT	38
	CALL ALSQRIN,A				DIRECT	39
	CALL BLQRIN,B)				DIRECT	40
40	CALL ALSQRIN,A,B,AE,BE,I1)				DIRECT	41
	CALL GOODFITPP,P1,N,2,3)				DIRECT	42
	CNTINUE				DIRECT	43
80	RETURN				DIRECT	44
	END				DIRECT	45

CARD NR. SEVERITY DETAILS DIAGNOSIS OF PROBLEM

AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.
AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.

SUBROUTINE DIRECT	74/74	OPT=1	FTN 4.5+614	06/01/76	14.04.49	PAGE
ENTRY POINTS	DEF LINE	REFERENCES				2
3 DIRECT	1	43				
SYMBOLIC REFERENCE MAP (R=3)						
VARIABLES	SN	TYPE	RELATION			
0 A	REAL	F.P.	REFS	32	38	DEFINED 1
0 AE	REAL	F.P.	REFS	40	DEFINED 1	DEFINED 1
L B	REAL	I.I.	REFS	33	40	DEFINED 1
0 BE	REAL	F.P.	REFS	40	DEFINED 1	
3 DEV	REAL	ARRAY A	REFS	4		
2260 EFF	REAL	ARRAY C	REFS	7		
2280 ERF	REAL	ARRAY B	REFS	5		
1 FLAG	INTEGER	A	REFS	2	4	
214 I	INTEGER	A	REFS	14	15	36 37
0 IND	INTEGER	ARRAY C	REFS	6	2*18	23 24
7020 IPFF	INTEGER	REFS 3	REFS	13	22	25
2 IPRAV	REAL	ARRAY B	REFS 4	7		
7020 IPRF	REAL	ARRAY A	REFS 3			
C IT	INTEGER	F.P.	REFS 40	DEFINED 1	1	
212 J	INTEGER		REFS 15	16	17	18 20
213 K	INTEGER		DEFINED 10	10	17	
0 M	INTEGER	F.P.	REFS 24	25	26	27 29
0 N	INTEGER	F.P.	DEFINED 11	11	26	
55			REFS 12	27		
0 PFF	REAL	ARRAY C	REFS 13	18	22	
1130 PP	REAL	ARRAY D	REFS 34	35	38	30 32 33
0 PRF	REAL	ARRAY B	REFS 9	33	35	
10150 P1	REAL	ARRAY B	REFS 5	14	16	
11300 P2	REAL	ARRAY B	REFS 5	41	41	
12430 P3	REAL	ARRAY B	REFS 5	33		
T	REAL	ARRAY D	REFS 5	35		
1130 TDFF	REAL	ARRAY C	REFS 7	23	25	
3410 TDCFF	REAL	ARRAY C	REFS 7	25	27	
3410 TDGRF	REAL	ARRAY B	REFS 5	16	18	
1130 TDGF	REAL	ARRAY B	REFS 5	16	18	
5670 VDCFF	REAL	ARRAY B	REFS 5	15		
5670 VICRF	REAL	ARRAY C	REFS 5	7		
6560 ZFFF	REAL	ARRAY B	REFS 5	5		
45560 ZRF	REAL	ARRAY B	REFS 5	7		
EXTERNALS	TYPE	ARCS	REFERENCES			
ABLSQAR		6	40			
ALSQAR		2	32	38		
BLSQAR		2	34	39		
GOODFIT		5	33	35	41	
SORT		1	30			
STATEMENT LABELS	DEF LINE	REFERENCES				
17 10	13	12				
30 15	18	14				
0 20	19	13				
41 30	22	12				

APPENDIX C

SUBROUTINE DIRECT		74/74 CPI=1		DEF LINE REFERENCES		FIN 4.5+414		06/01/76 14.04.49		PAGE	
STATEMENT LABELS		27 23								3	
52	35	0	60	28	22						
63	50	63	50	30	21						
66	55	66	55	31	12						
76	60	76	60	32	231						
116	70	116	70	37	31						
130	75	130	75	40	37						
145	80	145	80	42	36						
LOOPS	LABEL	INDEX	FROM-TU	LENGTH	PROPERTIES						
24	20	1	13 19	11B	OPT						
46	40	1	22 28	11B	OPT						
COMMON BLOCKS LENGTH		MEMBERS - BIAS NAME(LENGTH)									
A	4	0 IND	(1)	1 FLAG	(1)					2 IPRAM (1)	
6	6000	3 DEV	(1)	600 TORF	(600)					1200 ERF (600)	
		0 PRF	(600)	2400 ZRF	(600)					3000 VDCRF (600)	
		1800 TDCCRF	(600)	4200 P1	(600)					4800 P2 (600)	
C	4200	3600 IPRF	(600)								
		5400 P3	(600)								
		0 PF	(600)								
		1800 TDCCFF	(600)								
D	1200	3600 IPFF	(600)								
		0 T	(600)	600 PP	(600)						
STATISTICS											
PROGRAM LENGTH		2158		141							
CM LABELED COMMON LENGTH		262148		11404							

APPENDIX C

SUBROUTINE	WRITE	74/74	UPT=1	FTN 4.5+4.4	06/01/76	14.04.49	PAGE
1							1
5	SUBROUTINE WRITE(A,B,AE,BE,M,IT)						
	INTEGER FLAG			WRITE	2		
	COMMON/A/IND,FLAG,IPIRAM,DEV			WRITE	3		
	COMMON/S/GAUS(13),S			WRITE	4		
	GO TO 10,301,M			WRITE	5		
10	10 WRITE(6,20) DEV			WRITE	6		
	20 FORMAT(//,/,1X,43HREVERSE FAILURE CURVES AND DATA FOR DEVICE ,			WRITE	7		
	1A81			WRITE	8		
	GO TO 50			WRITE	9		
10	30 WRITE(6,40) DEV			WRITE	10		
	40 FORMAT(//,/,1X,43HFORWARD FAILURE CURVES AND DATA FOR DEVICE ,			WRITE	11		
	1A82			WRITE	12		
	50 GO TO 60,90,601,FLAG			WRITE	13		
	60 WRITE(6,70) A,GAUS(1)			WRITE	14		
15	70 FORMAT(//,10X,42HFITTING PARAMETER FOR P=A*T**(-1) 15: A= ,			WRITE	15		
	1IPE15.8,25X,7HOMEGA = ,1PE15.8)			WRITE	16		
	WRITE(6,80) B,GAUS(2)			WRITE	17		
	80 FORMAT(//,10X,43HFITTING PARAMETER FOR P=B*T**(-.5) 15: B= ,			WRITE	18		
	1IPE15.8,24X,7HOMEGA = ,1PE15.8)			WRITE	19		
20	1IAPLAC_EQ,1) RETURN			WRITE	20		
	90 WRITE(6,100) AE,GAUS(3),BE			WRITE	21		
	100 FORMAT(//,10X,46HFITTING PARAMETERS FOR P=A*T**(-1)+B*T**(-.5) ,			WRITE	22		
	1IPE15.8,12X,7HOMEGA = ,1PE15.8 ,/ ,62X,3MB= ,1PE15.8)			WRITE	23		
	19HARE: A = ,1PE15.8,12X,7HOMEGA = ,1PE15.8)			WRITE	24		
	WRITE(6,110) IT,5			WRITE	25		
	110 FORMAT(//,30X,17HA AND B FOUND IN *13,11H ITERATIONS,			WRITE	26		
	1IPE15.8,19HMINIMUM OF SCA,BF= ,1PE15.8)			WRITE	27		
	RETURN			WRITE	28		
	END			WRITE	29		

CARD NR. SEVERITY DETAILS DIAGNOSIS OF PROBLEM

5 1 AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.
13 1 AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	OFF LINE REFERENCES	REFS	DEFINED	REFS	DEFINED
3 WRITE	1 20	F.P. F.P.	14	REFS	1
0 A	REAL	REFS	21	REFS	1
0 AE	REAL	REFS	17	REFS	1
0 B	REAL	REFS	21	REFS	1
0 BE	REAL	REFS	21	REFS	1
3 DEV	REAL	A	3	REFS	10
1 FLAG	INTEGER	A	2	REFS	13
0 GAUS	REAL	ARRAY	4	REFS	20
0 IND	INTEGER	A	4	REFS	17
2 IPIRAM	INTEGER	A	3	REFS	21
0 IT	IPIRAM	F.P.	24	REFS	1

APPENDIX C

SUBROUTINE WRITE			74/74	OPT=1						
VARIABLES	SN	TYPE	RELOCUTION							
0 N		INTEGER	F.P.	F	E	REFS	REFS	REFS	REFS	REFS
3 S		REAL				5	4	4	24	1
FILE NAMES	MUDT									
TAPE6	FMT									
STATEMENT LABELS			WRITES	6		10	14	17	21	24
14 10			OFF LINE		REFERENCES					
50 20		FMT	6		5					
17 30		FMT	7		6					
63 40		FMT	10		5					
21 50		FMT	11		10					
31 60		FMT	13		9					
77 70		FMT	14		2 ^a 3					
115 80		FMT	15		14					
37 90		FMT	18		17					
134 100		FMT	21		13					
156 110		FMT	22		21					
			25		24					
COMMON BLOCKS	LENGTH		MEMBERS - BIAS NAME(LENGTH)							
A	6		0 IND (1)							
E	4		3 DEV (1)							
			0 GAUS (3)							
STATISTICS	PROGRAM LENGTH		1678	119						
	CN LABELED COMMON LENGTH		108	8						
					1 FLAG (1)					
					2 IPRAM (1)					

APPENDIX C

SUBROUTINE PLOT	74/74	OPT=1	F TN 4.5-414	06/01/76	14.04.49
			RITLEA(4)=10H FAILURE	PLOT	59
			RITLEA(5)=10H FIT TO	PLOT	60
			RITLEA(6)=10HP=41001-1	PLOT	61
			RITLEA(7)=10H DEVICE:	PLOT	62
			RITLEB(1)=10H	PLOT	63
			RITLEB(2)=DEV	PLOT	64
			RITLEB(3)=10H REVERSE	PLOT	65
			RITLEB(4)=10H FAILURE	PLOT	66
			RITLEB(5)=10H FIT TO	PLOT	67
			RITLEB(6)=10HP=801001-1-	PLOT	68
			RITLEB(7)=10HS1	PLOT	69
			IF(ISEM.EQ.0) GO TO 33	PLOT	70
		33	CALL CHANGE(KNUM,XTITLE,YTITLE,TDRF,PRF)	PLOT	71
			CALL PWRITE(2,RITLEA,XTITLE,YTITLE,BLANK,LEGEND,KNUM,TDRF,PRF,	PLOT	72
			11,P3)	PLOT	73
			IF(ISEM.EQ.1) GO TO 35	PLOT	74
			CALL PWRITE(1,EITLEA,XTITLE,YTITLE,BLANK,LEGEND,KNUM,TDRF,ERF,	PLOT	75
			10+0.)	PLOT	76
			IF(IFLAG.EQ.1) GO TO 50	PLOT	77
			40 RITLEA(1)=10H DEVICE:	PLOT	78
			RITLEA(2)=DEV	PLOT	79
			RITLEA(3)=10H REVERSE	PLOT	80
			RITLEA(4)=10H FAILURE	PLOT	81
			RITLEA(5)=10H FIT TO	PLOT	82
			RITLEA(6)=10HP=A1001-1	PLOT	83
			RITLEA(7)=10H+B9001-1-	PLOT	84
			RITLEB(8)=10HS1	PLOT	85
			IF(ISEM.EQ.0) GO TO 43	PLOT	86
			CALL CHANGE(KNUM,XTITLE,YTITLE,TDRF,PRF)	PLOT	87
			43 CALL PWRITE(2,RITLEB,XTITLE,YTITLE,BLANK,LEGEND,KNUM,TDRF,PRF,	PLOT	88
			11,P1)	PLOT	89
			IF(ISEM.EQ.1) GO TO 50	PLOT	90
			IF(IFLAG.EQ.3) GO TO 50	PLOT	91
			CALL PWRITE(1,EITLEA,XTITLE,YTITLE,BLANK,LEGEND,KNUM,TDRF,ERF,	PLOT	92
			10+0.)	PLOT	93
			50 CONTINUE	PLOT	94
			IF(IJ.EQ.1) RETURN	PLOT	95
			IJ(JNUM,E.G.) GO TU 130	PLOT	96
			GO TO 170,80+70)*FLAG	PLOT	97
			70 FITLEA(1)=10H DEVICE:	PLOT	98
			FITLEA(2)=DEV	PLOT	99
			FITLEA(3)=10H FORWARD	PLOT	100
			FITLEA(4)=10H FAILURE	PLOT	101
			FITLEA(5)=10H FIT TO	PLOT	102
			FITLEA(6)=10HP=A1001-1]	PLOT	103
			FITLEA(7)=10H	PLOT	104
			FITLEB(1)=10H DEVICE:	PLOT	105
			FITLEB(2)=DEV	PLOT	106
			FITLEB(3)=10H FORWARD	PLOT	107
			FITLEB(4)=10H FAILURE	PLOT	108
			FITLEB(5)=10H FIT TO	PLOT	109
			FITLEB(6)=10HP=B1001-1-	PLOT	110
			FITLEB(7)=10HS1	PLOT	111
			IF(ISEM.EQ.0) GO TO 73	PLOT	112
			CALL CHANGE(KNUM,XTITLE,YTITLE,TDRF,PRF)	PLOT	113
			1110	PLOT	114

APPENDIX C

FTN 4.5+614

SUBROUTINE	PLOTT	74/74	OPT=1	FTN 4.5+614	06/01/76	14.04.49	PAGE	3
115	73	CALL PWRITE(2,FTITLEA,XTITLE,YTITLE,BLANK,LEGEND,JNUM,TOFF,PFF,			PLOT	116		
	11,P2)	CALL PWRITE(2,FTITLEB,XTITLE,YTITLE,BLANK,LEGEND,JNUM,TOFF,PFF,			PLOT	117		
	11,P3)	CALL PWRITE(2,FTITLEC,XTITLE,YTITLE,BLANK,LEGEND,JNUM,TOFF,PFF,			PLOT	118		
120	1F(1SEM,FL,2)	G0 TU 75			PLOT	119		
	CALL PWRITE(1,FTITLEF,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,EFF,				PLOT	120		
	10..0..1				PLOT	121		
125	75	IF(IFLAG,FQ,1) GO TO 90			PLOT	122		
	80	FTITLEB(1)=10H DEVICE:			PLOT	123		
	FTITLEB(2)=DEV	FTITLEB(3)=10H FORWARD			PLOT	124		
	FTITLEB(4)=10H FAILURE	FTITLEB(5)=10H FIT TO			PLOT	125		
	FTITLEB(6)=10H P=+0.000(-1)	FTITLEB(7)=10H S=0.000(-1..			PLOT	126		
	FTITLEB(8)=10H5)				PLOT	127		
130	1F(1SEM,E,0)	GO TO 83			PLOT	128		
	CALL CHANGE(JNUM,XTITLE,YTITLE,TOFF,PFF)				PLOT	129		
	CALL PWRITE(2,FTITLEB,XTITLE,YTITLE,BLANK,LEGEND,JNUM,TOFF,PFF,				PLOT	130		
93	1T,P1)				PLOT	131		
	1F(1SEM,E,0,1)	GO TO 90			PLOT	132		
	1F(IFLAG,EG,3)	GO TO 90			PLOT	133		
	CALL PWRITE(1,ETITLEF,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,EFF,				PLOT	134		
	10..0..1				PLOT	135		
90	CONTINUE				PLOT	136		
140	1F(JNUM,EQ,0)	GO TO 130			PLOT	137		
	1F(J,EG,2)	RETURN			PLOT	138		
	100	GO TU (11G,12G,11G,11G),IPRM			PLOT	139		
	110	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,KNUM,TDRF,ZRF,			PLOT	140		
	10..0..1				PLOT	141		
145	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,KNUM,TDRF,VOCR,				PLOT	142		
	10..0..1	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,KNUM,TDRF,VOCR,			PLOT	143		
	IVOCR,0,0,1)	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,KNUM,TDRF,VOCR,			PLOT	144		
	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,KNUM,TDRF,VOCR,				PLOT	145		
150	10..0..1	IF(IPRM,EQ,1) RETURN			PLOT	146		
	120	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,2FF,			PLOT	147		
	10..0..1	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,VOCFF,			PLOT	148		
	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,VOCFF,				PLOT	149		
155	10..0..1	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,VOCFF,			PLOT	150		
	IVOCFF,0,0,1)	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,1PFF,			PLOT	151		
	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,1PFF,				PLOT	152		
	10..0..1	CALL PWRITE(1,ETITLE,XTITLE,YTITLE,BLANK,BLANK,JNUM,TOFF,2FF,			PLOT	153		
	130	STEP			PLOT	154		
	END				PLOT	155		
					PLOT	156		
					PLOT	157		
					PLOT	158		
					PLOT	159		
					PLOT	160		
160	10..0..1	RETURN			PLOT	161		
	130	STEP			PLOT	162		
	END				PLOT	163		

CARD NR. SEVERITY DETAILS DIAGNOSIS OF PROBLEM

AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.
 AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.

APPENDIX C

SUBROUTINE PLOT1				74/74	UPT=1		FTN 4.5+4.14	06/01/76	14.04.49	PAGE	4
SYMBOLIC REFERENCE MAP (LR=3)											
ENTRY POINTS	DEF LINE	REFERENCES									
3 PLOT1	1	96	141								
VARIABLES	SN	TYPE		REFS	13	71	73	2076	89	2093	115
1036	BLANK	REAL	ARRAY	REFS	20120	133	20137	20163	20145	20147	50
3	DEV	REAL	A	REFS	20152	20154	20158	DEFINED	15	49	50
2260	FFF	REAL	ARRAY	REFS	107	124	28	34	56	60	100
2260	ERF	REAL	ARRAY	REFS	7	120	137	137	152	154	156
766	ETITLEF	REAL	ARRAY	REFS	5	76	93	137	152	156	158
726	ETITLER	REAL	ARRAY	DEFINED	15	33	34	35	36	145	147
1	FLAG	INTEGER	A	REFS	11	76	93	143	145	147	149
776	FTITLEB	REAL	ARRAY	REFS	136	2	4	54	29	30	30
746	FTITLEA	REAL	ARRAY	REFS	11	133	133	133	15	123	124
756	FTITLEB	REAL	ARRAY	REFS	126	127	128	129	130	125	125
0	I ND	INTEGER	A	REFS	11	115	115	115	15	99	100
705	I P	REAL	>UNDEF	REFS	102	103	104	105	105	106	101
0	I PLOT	INTEGER	ARRAY	REFS	109	111	111	112	106	107	108
2	I PRAM	REAL	ARRAY	REFS	4	7	7	158			
1	I SEM	INTEGER	F	REFS	10	142	151	151			
7020	I PF	REAL	ARRAY	REFS	3	149	149	149			
1033	LEGFN	INTEGER	F.P.	REFS	131	69	75	87	91	113	119
0	J NUM	INTEGER	F.P.	REFS	135	135	147	149	149	141	141
0	P FF	REAL	C	REFS	52	53	96	96	141	141	141
1130	PP	REAL	ARRAY	REFS	97	114	115	117	120	132	133
0	PRF	REAL	D	REFS	137	160	152	156	156	156	156
10150	1	REAL	ARRAY	REFS	10	69	75	87	91	113	119
11300	P2	REAL	ARRAY	REFS	131	145	147	149	149	149	149
12430	P3	REAL	ARRAY	REFS	10	13	71	73	76	86	93
736	RTITLEB	REAL	ARRAY	REFS	143	145	147	149	149	149	149
0	T	REAL	ARRAY	REFS	15	66	66	67	67	63	64
1130	T OFF	REAL	C	REFS	7	114	115	117	117	117	117

APPENDIX C

SUBROUTINE PLUTT	74/74	OPT=1				PAGE	6
COMMON BLOCKS	LENGTH	MEMBERS - BIAS NAME(LENGTH)					
C	4200	0 PFF (600) 1000 TDCCFF (600) 3600 IPFF (600) 0 T (600) 0 IPLOT (1)	600 TDFF (600) 2400 ZFF (600) 600 PP (600) 1 ISEM (1)				
D	1200						
F	3						
STATISTICS							
PROGRAM LENGTH	10416	545					
CM LABELED COMMON LENGTH	262176	11407					

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SUBROUTINE ALSQAR(N,A)
REAL IPRF
COMMON/B/PRF(600),TDRF(600),ERF(600),TDOCREF(600),ZRF(600),
      VCRF(600),IPRF(600),P1(600),P2(600),P3(600)
      COMMON/D/T1(600),P1(600)
      SUMTC=0.
      SUMCP=0.
DO 10 I=1,N
      SUMTC=SUMTC+ALOG10(T(I))
      SUMCP=SUMCP+ALOG10(P(I))
CONTINUE
      ARG=(SUMTC+SUMCP)/N
      A=0.0*ARG
      DO 20 I=1,N
      P2(I)=A*T(I)+(-1)
      20 RETURN
      END

```

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES					
3 ALSQAR	1	16					
VARIABLES	SN	TYPE	RELOCATION				
0 A		REAL	F.P.				
53 ARG		REAL	ARRAY B	REFS	15	DEFINED	13
2260 ERF		REAL	ARRAY B	REFS	13	DEFINED	12
52 I		INTEGER	ARRAY B	REFS	9	10	14
7020 IPRF		REAL	ARRAY B	REFS	2	3	
0 N		INTEGER	ARRAY D	REFS	8	12	14
1130 PP		REAL	ARRAY B	REFS	5	10	
0 PRF		REAL	ARRAY B	REFS	3	3	
10150 P1		REAL	ARRAY B	REFS	3	3	
11300 P2		REAL	ARRAY B	REFS	3	3	
12430 P3		REAL	ARRAY B	REFS	3	3	
51 SUMCP		REAL	REFS	REFS	10	12	15
50 SUMTC		REAL	REFS	REFS	9	12	10
0 T		REAL	ARRAY D	REFS	5	9	9
3410 TDOCREF		REAL	ARRAY B	REFS	3	3	
1130 TDRF		REAL	ARRAY B	REFS	3	3	
5670 VCRF		REAL	ARRAY B	REFS	3	3	
4540 ZRF		REAL	ARRAY B	REFS	3	3	
EXTERNALS	TYPE	ARG'S	REFERENCES				
A LOG10	REAL	1 LIBRARY	9	10			
STATEMENT LABELS		DEF LINE	REFERENCES				
0 10		11	8				
0 20		15	14				
LOOPS	LABEL	INDEX	FROM-TO LENGTH	PROPERTIES	EXT REFS	EXT REFS	
20 10 * 1		8 11	118				
40 20 * 1		14 15	68				

APPENDIX C

SUBROUTINE ALSQAR		74/74 OPT=1	FTN 4.5+614	06/01/76 14.04.49	PAGE 2
COMMON BLOCKS LENGTH		MEMBERS - BIAS NAME(LENGTH)			
B	6000	0 PRF (600) 1800 TDDCAF (600) 3600 IPKF (600) 5400 P3 (600) 0 T (600)	600 TDRF (600) 2400 ZRF (600) 4200 P1 (600) 600 PP (600)	1200 ERF (600) 3000 VOCRF (600) 4800 P2 (600)	
D	1200				
STATISTICS					
PROGRAM LENGTH IN LABELED COMMON LENGTH		61B 49 16040B 7200			

PAGE 1

ROUTINE BLSSQR 74/74 OPT=1 FTN 4.5+414 06/01/76 14.04.49

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1      SUBROUTINE BLSSQR(M,B)
      REAL TDF,PRF(600),TDRF(600),ERF(600),TDCRF(600),ZNF(600),
      COMMON/B/PRF(600),TDF(600),ERF(600),TDCRF(600),ZNF(600),
      1          VDRCF(600),IPRF(600),P1(600),P2(600),P3(600)
      SUMD=0.
      SUMDP=0.
      DO 10 I=1,N
      SUMD=SUMD+ALOG10(T(I))
      SUMDP=SUMDP+ALOG10(P(I))
10      CONTINUE
      ARG=(SUMDP+.5*SUMTD)/N
      B=10.*ARG
      DD 20 I=1,N
      20 P3(I)=B*1((I)*0(-.5)
      RETURN
      END

```

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES
3 BLSSQR	1	16
VARIABLES		
55 ARG	SN TYPE	RELOCATION
0 B	REAL	F.P.
2260 ERF	REAL	ARRAY B
54 I	INTEGER	
7020 IPRF	REAL	ARRAY B
0 Y	INTEGER	F.P.
1130 PP	REAL	ARRAY D
0 PRF	REAL	ARRAY B
10150 P1	REAL	ARRAY B
11300 P2	REAL	ARRAY B
12300 P3	REAL	ARRAY B
53 SUMD	REAL	
52 SUMTD	REAL	
0 T	REAL	ARRAY C
3610 TDCRF		ARRAY B
1130 TDRF		ARRAY B
5670 VDRCF		ARRAY B
4560 ZRF		ARRAY B
EXTERNALS		
ALOG10	TYPE	ARGS REFERENCES
	REAL	1 LIBRARY 9 10
STATEMENT LABELS		
0 10		DEF LINE REFERENCES
0 20		11 6
		15 14
LOOPS		
20 10	LABEL INDEX	FROM-TO LENGTH PROPERTIES EXT REFS
40 20.	* 1	6 11 118
		14 15 68
		EXT REFS

APPENDIX C

SUBROUTINE BLSSQR		74/74	OPT=1	FTN 4.5+4.14	06/01/76	14.04.49	PAGE
COMMON BLOCKS		LENGTH	MEMBERS - BIAS NAME(LENGTH)				2
B	6000	0	PRF (600)	600 TDRF (600)	1200 EAF (600)		
		1800	TDOCAF (600)	2400 ZRF (600)	3000 YDCRF (600)		
		3600	IPRF (600)	4200 P1 (600)	4800 P2 (600)		
D	1200	5400	P3 (600)	600 PP (600)			
		0	T (600)				
STATISTICS							
PROGRAM LENGTH		638	51				
CN LABEL(F) COMMON LENGTH		160408	7200				

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SUBROUTINE ABLSQAR      74/74   QPT=1          FIN 4.5+4.14      06/01/76   14.04.49
1   SURROUNTR ABLSQAR, A1, B1, AE, BE, JT           PAGE 1
      REAL IPRF
      COMMON/A/IND,FLAG,J,PRAN,DEV
      COMMON/B/PRF(600),DRF(600),ERF(600),TDOCRF(600),7RF(600),
      1   COMMON/VCKF(600),IPRF(600),P1(600),P2(600),P3(600)
      COMMON/E/GAUSS13),5
      DIMENSION A(500),B(500)
      I=1
      J=1
      EPS=1.E-4
      A(I)=A1
      B(I)=B1
      L=0
10     S1=SAB(N,A(I)),B(I))
      A=A(I)/J
      A(I+1)=A(I)-A1
      IF(SAB(N,A(I+1),B(I))<L1,S1) GO TO 20
      A(I+1)=A(I)+I
      IF(SAB(N,A(I+1),B(I))>L1,S1) GO TO 20
      A(I+1)=A(I)
      GC TO 30
20     L1=B(I)/(2.+J)
      B(I+1)=B(I)-B1
      IF(SAB(N,A(I+1),B(I+1))-L1,S1) GO TO 40
      B(I+1)=B(I)+B1
      IF(SAB(N,A(I+1),B(I+1))-L1,S1) GO TO 40
      B(I+1)=B(I)
      GC TU 50
30     L1
      50    IF(L.EQ.1) GO TO 60
      J=I+1
      IF(J.GT.20) GO TO 90
      J=J+1
      GO TU 10
60     S=SAB(N,A(I+1),B(I+1))
      ER=ABS(S-S1)
      IF(ER.LT.EPS) GO TO 70
      J=J+1
      GO TU 10
70     A=A(I+1)
      BE=B(I+1)
      I=I+1
      DO 80 I=1,N
80     P((I)-AE*T(I))**(-1)+BE*T(I)**(-.5)
      GO TO 110
      WRITE(6,100)
100    FORMAT(//,1X,41NUMBER OF ITERATIONS FOR 2+0J EXCEED J=20)
      110  RETURN
      END

```

APPENDIX C

SUBROUTINE ARLSQAR				74774	DPI=1	F7N 4.5A414	06/01/76	14.04.49	PAGE	2			
SYMBOLIC REFERENCE MAP (R=3)													
ENTRY POINTS	DEF LINE	REFERENCES											
3	ARLSQAR												
VARIABLES	SN	TYPE	RELOCATIUN	REFS	8	15	16	17	18	19	20		
213	A	REAL	ARRAY	REFS	21	26	28	37	42	DEFINED	12		
0	AF	REAL	F.P.	REFS	19	21	46	DEFINED	1	42	17		
0	A1	REAL	F.P.	REFS	12	17	19	DEFINED	1	16			
210	A1	REAL	ARRAY	REFS	17	8	15	18	20	DEFINED	25		
1177	B	REAL	ARRAY	REFS	27	28	29	37	43	DEFINED	13		
0	BE	REAL	F.P.	REFS	27	29	46	DEFINED	1	43			
0	B1	REAL	F.P.	REFS	13	12	13	DEFINED	1	1			
211	B1	REAL	ARRAY	REFS	25	25	27	DEFINED	1	24			
3	DEV	REAL	A	REFS	3	3	3	3	3	3			
205	EPS	REAL	ARRAY	REFS	39	39	39	DEFINED	11	11			
2260	ERF	REAL	ARRAY	REFS	4	4	4	4	4	4			
212	ERR	REAL	ARRAY	REFS	39	39	39	DEFINED	38	38			
1	FLAG	REAL	A	REFS	3	3	3	3	3	3			
0	SAUS	REAL	ARRAY	REFS	7	12	13	2015	16	2017	2019		
203	I	INTEGER	E	REFS	2*20	2*21	24	2025	2*26	2*27	2*29		
0	IND	INTEGER	A	REFS	33	33	40	42	43	44	3*46		
2	IPRM	REAL	ARRAY	REFS	3	3	33	40	45	45			
7020	IPRF	INTEGER	B	REFS	2	4	4	4	4	4			
0	IT	INTEGER	F.P.	DEFINED	1	1	16	24	34	35			
204	J	INTEGER	ARRAY	REFS	32	32	32	DEFINED	14	31	35		
206	L	INTEGER	ARRAY	REFS	15	18	20	20	26	26	45		
0	N	INTEGER	F.P.	DEFINED	1	1	15	18	20	20			
1130	PP	REAL	ARRAY	REFS	1	1	1	1	1	1			
0	PRF	REAL	ARRAY	REFS	6	6	6	6	6	6			
10150	P1	REAL	ARRAY	REFS	4	4	4	4	4	4			
11300	P2	REAL	ARRAY	REFS	4	4	4	4	4	4			
12430	P3	REAL	ARRAY	REFS	4	4	4	4	4	4			
3	S	REAL	E	REFS	7	7	7	38	38	38			
207	SJ	REAL	DEFINED	REFS	18	20	20	26	26	26	36		
0	T	REAL	ARRAY	REFS	6	6	6	2046	6	6			
3410	TOOCRF	REAL	ARRAY	REFS	4	4	4	4	4	4			
1130	TDRF	REAL	ARRAY	REFS	4	4	4	4	4	4			
5670	VOOCRF	REAL	ARRAY	REFS	4	4	4	4	4	4			
4540	ZRF	REAL	ARRAY	REFS	4	4	4	4	4	4			
FILE NAMES	MODE	WRITES	REFERENCES	48	48	48	48	48	48	48	48		
EXTERNALS	MAPF6	TYPE	ARGS	15	18	20	20	20	20	20	20		
EXTERNALS	SAB	REAL	3	3	3	3	3	3	3	3	3		

SUBROUTINE ABSQSR		74/74		OPT=1		FTN 4.5+616		06/01/76		14-04-49		PAGE 3	
INLINE FUNCTIONS	TYPE	ARGS	1	INTRIN	DEF LINE	REFERENCES	38						
ABS	REAL					DEF LINE	REFERENCES						
STATEMENT LABELS													
23	10		14		36	41							
60	20		23		18	20							
61	30		24		22								
110	60		31		26								
111	50		32		30								
117	60		37		32								
133	70		42		39								
154	90		46		45								
170	100	FMT	48		34								
156	110		49		48								
161	80	*	50		47								
LOOPS													
	LABEL	INDEX		FROM-TO	LENGTH		PROPERTIES						
	161	80	*	45 46	13B		EXT REFS						
COMMON BLOCKS													
A	LENGTH	4		MEMBERS - BIAS NAME(LENGTH)									
B	6000		0 IND	(1)			1 FLAG	(1)					
D	1200	4	3 DEV	(1)									
E			0 PRF	(600)									
			1800 TDCRF	(600)			600 TDRF	(600)					
			3600 IPRF	(600)			2400 ZRF	(600)					
			5400 P3	(600)			4200 P1	(600)					
			0 T	(600)			600 PP	(600)					
			0 GAUS	(3)			3 S	(1)					
STATISTICS													
PROGRAM LENGTH			21778		1151								
CM LABELED COMMON LENGTH			160508		7208								

APPENDIX C

```

SUBROUTINE PWRITE      74/74    OPT=1          FTN 4.5+414      06/01/76  14.04.49
COMMON//1PILOT,1SEN,1TYPE
DIMENSION X(600),Y(600),XX(600),YY(600)
DIMENSION T(1),XT(13),YT(13),GLD(13),GLL(13)
IF(1TYPE.EQ.-1) GO TO 10
CALL SELPLOT(1PILOT)
CALL TALGRAF(K,0,0,0,0,0,0,T,XT,YT)
CALL TALDATA(N,X,Y,I,J,GLD)
IF(K.EQ.-1) RETURN
CALL TALDATA(N,XX,YY,I,J,GLL)
RETURN
CONTINUE
CALL DRAM41(7,3,3,2,8,RT,VT,GLL,T)
CALL DRAM42(7,2,N,-2,1D,X,Y,0,0,0)
IF(K.EQ.1) GO TO 20
CALL DRAM42(7,2,N,0,1D,XX,YY,0,0,0)
CALL DRAM43(7,2,0,2,N,XX,YY,2,0,0)
RETURN
END

```

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES								
3 PWRITE	1	9	11	18						
VARIABLES	SN	TYPE	RELOCATION							
0 GLD	REAL	ARRAY	F.P.	REFS	4	6	DEFINED			
0 GLL	REAL	ARRAY	F.P.	REFS	4	10	13	DEFINED		
0 1PILOT	INTEGER	ARRAY	F	REFS	2	6				
1 1SEN	INTEGER	ARRAY	F	REFS	2					
2 1TYPE	INTEGER	ARRAY	F	REFS	2	5				
0 K	INTEGER	ARRAY	F.P.	REFS	7	9	15	DEFINED		
0 N	INTEGER	ARRAY	F.P.	REFS	6	10	14	16	17	DEFINED
0 T	REAL	ARRAY	F.P.	REFS	4	7				
0 X	REAL	ARRAY	F.P.	REFS	3	6	13	DEFINED		
0 XT	REAL	ARRAY	F.P.	REFS	4	7	13	DEFINED		
0 XX	REAL	ARRAY	F.P.	REFS	3	10	16	17	DEFINED	
0 Y	REAL	ARRAY	F.P.	REFS	3	6	14	DEFINED		
0 YT	REAL	ARRAY	F.P.	REFS	4	7	13	DEFINED		
0 YY	REAL	ARRAY	F.P.	REFS	3	10	16	17	DEFINED	
EXTERNALS	TYPE	ARGS	REFERENCES							
		10	13	14	16	17				
		1	6							
		7	8	10						
		10	7							
STATEMENT LABELS	DEF LINE	REFERENCES								
41	12	5								
10	17	15								
67	20									

APPENDIX C

SUBROUTINE PWRITE		74/74	OPT=1	FTN 4.5+414	06/01/76	14.04.49	PAGE
COMMON BLOCKS	F	LENGTH 3	MEMBERS - BIAS NAME(LENGTH)				2
			0 IPLOT (1)	1 1SEM (1)			
STATISTICS					2 1TYPE (1)		
PROGRAM LENGTH							
CH LABELED COMMON LENGTH		2208 144	38 3				

APPENDIX C

```

SUBROUTINE SORT
74/74   DPT=1

      1      SUBROUTINE SORT(N)
      1      COMMON/D/1(600),P(600)
      1      DIMENSION E(600),H(600)
      1      J=1
      1      J=0
      10     TDMIN=1.E300
      10     DO 20 L=1,N
      10     TDMIN=AMIN(TDMIN,T(L))
      10     IF(TDMIN.EQ.T(L)) J=L
      20     CONTINUE
      20     IF(TDMIN.GT.1.E50) GO TO 40
      20     E(L)=P(L)
      20     H(L)=TDMIN
      15     I=I+1
      15     T(I)=1.E51
      15     GO TO 10
      40     CONTINUE
      40     DO 50 L=1,N
      40     P(L)=E(L)
      40     T(L)=H(L)
      50     CONTINUE
      50     RETURN
      END

```

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES
3	SORT	1
VARIABLES		
51 E	REAL	REFS
1201 H	REAL	REFS
45 I	INTEGER	REFS
46 J	INTEGER	REFS
50 L	INTEGER	REFS
0 Y	INTEGER	REFS
1130 PP	REAL	F.P.
0 T	REAL	REFS
47 TDMIN	REAL	REFS
INLINE FUNCTIONS		
AMINI	REAL	REFS
STATEMENT LABELS		
7	10	DEF LINE
0	20	6
32	60	10
0	50	17
LOOPS		
13	20	INDEX
35	50	FROM-TO
PROPERTIES		
		LENGTH
		68
		INSTACK
		INSTACK

APPENDIX C

SUBROUTINE SORT	74/74	OPT=1	FTN 4.5+4.1e	06/01/76	14.04.49	PAGE
COMMON BLOCKS	LENGTH	MEMBERS - BIAS NAME(LENGTH)				2
D	1200	O T (600)	600 PP (600)			
STATISTICS						
PROGRAM LENGTH	23318	1241				
CM LABELED COMMON LENGTH	22608	1200				

APPENDIX C

```

1      SUBROUTINE GOODFIT(Y,V1,N,M,J)
2      INTEGER FLAG
3      COMMON/A/IND,FLAG,JPRM,DEV
4      COMMON/E/GAUS(3),S
5      DIMENSION Y(1600),V1(600)
6      IF(FLAG.EQ.2) RETURN
7      SUM=0.
8      DO 10 I=1,N
9      YI=ALOG10(V1(I))
10     YI=SUM+(YI-Y11)*0.2
11     CONTINUE
12     GO TO 120,30,40,J
13     GAUS(1)=SUM/(N-1)
14     RETURN
15     GAUS(2)=SUM/(N-M)
16     RETURN
17     GAUS(3)=SUM/(N-M)
18     RETURN
19     RETURN
20     END
21

```

CARD NR.	SEVERITY	DETAILS	DIAGNOSIS OF PROBLEM
13	1		AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.

SYMBOLIC REFERENCE MAP (B = 3)

ENTRY POINT	DEF LINE	REFERENCES	6	15	17	19	
VARIABLES	SN	TYPE	RELOCATION				
3 GOODFIT	1		A				
3 DEV	3	REAL	REFS	3			
3 GUS	3	INTEGER	REFS	2	3		
1 FLAG	1	REAL	REFS	6	DEFINED	14	
6C 1	6C	INTEGER	ARRAY	E	10	DEFINED	6
1 IND	1	INTEGER	A	REFS	9		18
2 IPRAM	2	INTEGER	A	REFS	3		
0 J	0	INTEGER	F.P.	REFS	3		
0 K	0	INTEGER	F.P.	REFS	13	DEFINED	1
0 N	0	INTEGER	F.P.	REFS	14	18	DEFINED
3 S	3	REAL	F.P.	REFS	16	18	DEFINED
57 SUM	57	REAL	E	REFS	8	14	DEFINED
0 V	0	REAL	ARRAY	F.P.	4		1
62 YIL	62	REAL	ARRAY	REFS	11	14	DEFINED
61 VL	61	REAL	ARRAY	REFS	5	9	DEFINED
				REFS	5	10	DEFINED
				REFS	11	16	DEFINED
				REFS	11	18	DEFINED
				REFS	11	10	DEFINED
				REFS	11	11	DEFINED

APPENDIX C

SUBROUTINE CJ00DFIT		74/74	OPT=1		FTN 4,5+416	06/01/76	14.04.49	PAGE 2
STATEMENT LABELS		DEF LINE	REFERENCES					
0	10	12	8					
42	20	14	13					
46	30	16	13					
52	40	18	13					
LOOPS	LABEL	INDEX	FROM-TO	LENGTH	PROPERTIES	EXT REFS		
21	10	*	1	8 12	128			
COMMON BLOCKS		LENGTH	MEMBERS - BIAS NAME(LENGTH)					
A		4	0 IND (1)		1 FLAG (1)			
E		4	3 DEV (1)		2 IPRAM (1)			
STATISTICS			0 GAUS (3)					
PROGRAM LENGTH			758	61				
CM LABELED COMMON LENGTH			108	8				

APPENDIX C

CARD NR.	SEVERITY	DETAILS	DIAGNOSIS OF PROBLEM
18	1		AN IF STATEMENT MAY BE MORE EFFICIENT THAN A 2 OR 3 BRANCH COMPUTED GO TO STATEMENT.

```

1      SUBROUTINE GAUSS      74/74   OPT=1          FTN 4.5+414      06/01/76  14.04.49      PAGE 1
1
2      INTEGER FLAG
3      COMMON/A/IND,FLAG,IPRAM,DEV
4      COMMON/E/GAUS(3),S
5      J=3
6      IF(FLAG.EQ.2) RETURN
7      IF(FLAG.EQ.1) J=2
8      GMIN=1.E300
9      DO 10 I=1,J
10     GMIN=MIN(GMIN,GAUS(I))
11     CONTINUE
12     DO 15 I=1,J
13     IF(GMIN.EQ.GAUS(I)) L=I
14     CONTINUE
15     WRITE(6,20)
16     FORMAT(1/,5X,34HGAUSS CRITERION OF GOODNESS OF FIT,/,10X,
17     145HTHE EQUATION WHICH BEST FITS THIS DATA IS: )
18     GO TO (30,50,70),L
19     WRITE(6,*)
20     40 FORMAT(1/,30X,11HP=A*10**(-1))
21     RETURN
22     50 WRITE(6,*)
23     60 FORMAT(1/,30X,12HP=B*10**(-.5))
24     RETURN
25     70 WRITE(6,*)
26     80 FORMAT(1/,30X,22HP=A*10**(-1)+B*10**(-.5))
27     RETURN
28     END
29     GAUSS

```

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES	RELOCATION
1 GAUSS	1	6	A
3 DEV			REFS
1 FLAG			REFS
0 GAUS			REFS
117 GMIN			REFS
REAL			REFS
120 I			REFS
0 IND			REFS
2 IPRAM			REFS
116 J			REFS
121 L			REFS
3 S			REFS
REAL			E
		21	
		24	
		27	
VARIABLES	SN	TYPE	

APPENDIX C

SUBROUTINE GAUSS		74/74		OPT = 1		FTN 4.5+14		06/01/76 14.04.49		PAGE 2	
FILE NAMES	MODE			WRITES	15	DEF LINE	REFERENCES	19	22	25	
TAPE6	FMT			0	INTRIN						
INLINE FUNCTIONS	TYPE	ARGS									
AMINI	REAL										
STATEMENT LABELS			DEF LINE	REF							
0 10			11	9							
0 15			14	12							
55 20	FMT		16	15							
41 30			19	18							
73 40	FMT		20	19							
44 50			22	18							
101 60	FMT		23	22							
47 70			25	18							
110 80	FMT		26	25							
LOOPS	LABFL	INDEX	FROM-TO	LENGTH	PROPERTIES						
13 10		1	9 11	4B	INSTACK						
22 15		1	12 14	4B	INSTACK						
COMMON BLOCKS	A	LENGTH	MEMBERS - BIAS NAME(LENGTH)			1 FLAG (1)					
	E	4	0 IND (1)			3 DEV (1)					
			0 GAUS (3)			3 S (1)					
STATISTICS	PROGRAM LENGTH		1228	82							
	CM LABELED COMMON LENGTH		108	6							

APPENDIX C

FUNCTION	SAB	74 / 74	OPT=1	FTN 4.5+614	06 / 01 / 76	14.04.49	PAGE	1
1				SAB	2			
	FUNCTION SAB(A,B)			SAB	3			
	COMMON/D/(600),PP(600)			SAB	4			
	SUM=0.			SAB	5			
5	NN=N			SAB	6			
	AA=A			SAB	7			
	BB=B			SAB	8			
	DO 10 I=1,MN			SAB	9			
	ARG=A*(I-1)*(-1)+B*B*(I-1)*(-.5)			SAB	10			
	AL=1.0E+100			SAB	11			
	IF(ARG.GT.0.) AL=ALOG10(ARG)			SAB	12			
10	PL=ALOG10(PP(I))			SAB	13			
	SUM=SUM+(PL-AL)*2			SAB	14			
	CONTINUE			SAB	15			
	SAB=SUM			SAB	16			
	RETURN			SAB	17			
15	END							

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES						
4	SAB	1	15					
VARIABLES	SN	TYPE	RELOCATION					
0 A	REAL		F.P.					
53 AA	REAL		REFS	5	DEFINED	1		
57 AL	REAL		REFS	8	DEFINED	5		
56 ARG	REAL		REFS	12	DEFINED	10		
0 B	REAL		REFS	2*10	DEFINED	9		
54 BB	REAL		REFS	6	DEFINED	6		
55 I	INTEGER		REFS	6	DEFINED	6		
0 N	INTEGER		REFS	2*6	DEFINED	7		
52 MN	INTEGER		REFS	4	DEFINED	1		
60 PL	REAL		REFS	7	DEFINED	4		
1130 PP	REAL	ARRAY D	REFS	12	DEFINED	11		
50 SAB	REAL		REFS	2	DEFINED	11		
51 SUM	REAL		REFS	14	DEFINED	3		
0 T	REAL	ARRAY D	REFS	12	DEFINED	3		
EXTERNALS	TYPE	ARGS REFERENCES						
A LOG10	REAL	1 LIBRARY 10	11					
STATEMENT LABELS		DEF LINE REFERENCES						
0 10		13 7						
LOOPS	LABEL INDEX	FROM-TO LENGTH	PROPERTIES					
15 10	*	7 13 258	EXT REFS					
COMMON BLOCKS	LENGTH	MEMBERS - BIAS NAME LENGTH						
D	1200	0 1 (600)	600 PP (600)					
STATISTICS								
PROGRAM LENGTH		618	49					
CM LABELED COMMON LENGTH		22608	1200					

APPENDIX C

SUBROUTINE	QWORDAT	T4/T4	DPT=1	RELOCATION	REFS	FTN 4.5+4.14	06/01/76	14.04.49	PAGE
VARIABLES									2
272 BE	REAL	G		REFS	29	30	36	37	
6 DDEV	REAL	A		REFS	6	14			
3 DEV	REAL	C		REFS	3	14			
0 DEVTYPE1	REAL	C		REFS	6	14			
1 DEVTYPE2	REAL	C		REFS	6	14			
1 FLAG	REAL	A		REFS	3	14			
266 I	INTEGER	A		REFS	2*10	DEFINED	9		
262 IDENT1	INTEGER	F		REFS	18	DEFINED	7		
263 IDENT2	INTEGER	G		REFS	18	DEFINED	7		
0 IND	INTEGER	A		REFS	3	28	34		
0 IPLT	INTEGER	F		REFS	5				
2 IPRAM	INTEGER	A		REFS	3				
1 ISEM	INTEGER	F		REFS	5				
7 ISTOP	INTEGER	G		REFS	6				
273 IT	INTEGER	G		REFS	29	30	32	39	
2 ITYPE	INTEGER	F		REFS	5		36	37	
2 JUNC	REAL	G		REFS	2	6	14		
3 MAN1	REAL	G		REFS	2	6	14		
4 MAN2	REAL	G		REFS	2	6	14		
0 NUMB	INTEGER	F..P.		REFS	9	6	14		
1130 PP	REAL	ARRAY D		DEFINED	1	24	29	2*33	
0 T	REAL	ARRAY D		REFS	4	24			
5 TECH	REAL	G		REFS	4	24			
264 XLAB	REAL			REFS	6	14			
265 YLAB	REAL			REFS	3*20	DEFINED	7		
FILE NAMES	MODE			READS	7	10			
TAPES	FMT			WRITES	14	18	20	22	25
TAPES	FMT								
EXTERNALS	TYPE	ARGS		REFERENCES					
COLMNS		3		26					
DIRECT		7		29					
GAUSS		0		31					
PLOTT		3		33					
WRITE		6		30					
STATEMENT LABELS				DEF LINE REFERENCES					
154 10	FMT			8	7				
165 20	FMT			11	10				
0 30				12	9				
202 40	FMT			15	14				
224 50	FMT			19	18				
241 60	FMT			21	20				
247 70	FMT			23	22				
255 80	FMT			26	25				
67 85				27	13				
64 88				34	32				
66 90				35	28				
101 100				41	34				
LOOPS	LABEL	INDEX		FROM-TO LENGTH PROPERTIES EXIT REFS					
20 30	*	1		9 12 11B					

APPENDIX C

SUBROUTINE DNDAT		74/74	OPT=1		FTN 4.5+4.14		06/01/76	14.04.49	PAGE	3
COMMON BLOCKS LENGTH		MEMBERS - BIAS NAME(LENGTH)			1 FLAG (1)					
A	4	0 IND (1)			600 PP (600)					
		3 DEV (1)			1 ISHM (1)					
D	1200	0 T (600)			2 ITYPE (1)					
		0 IPLOT (1)			3 JUNC (1)					
F	3	0 DEVTP1(1)			4 MAN2 (1)					
G	6	3 MAN1 (1)			5 TECH (1)					
		6 DATEE (1)			7 1STOP (1)					
STATISTICS										
PROGRAM LENGTH		2768	190							
CM LABELED COMMON LENGTH		22776	1215							

APPENDIX C

```

SUBROUTINE COLMNS(KPTS,X,Y)
DIMENSION X(1),Y(1),
          INCKPTS/3
        40  ICOL=MOD(KPTS,3)
          INC=INC+1
          IF(IK.EQ.0) GO TO 50
          IF(IK.EQ.1) GO TO 70
          IF(IK.EQ.2) GO TO 80
      50  WRITE(6,60) (X(I),Y(I),X(I+INC),Y(I+INC)),X(I+2*INC),Y(I+2*INC),
           I1=1,INC)
      60  FORMAT(3(1X,1PE1.3,3X,1PE11.3))
      GO TO 90
      70  WRITE(6,60) (X(I),Y(I),X(I+INC),Y(I+INC)),X(I+ICOL),Y(I+2*ICOL-1),
           Y(I+2*(COL-1)),I=1,INC)
          WRITE(6,60) X(ICOL),Y(ICOL)
      GO TO 90
      80  WRITE(6,60) (X(I),Y(I),X(I+ICOL),Y(I+ICOL)),X(I+2*ICOL),
           Y(I+2*(COL-1)),I=1,INC)
          WRITE(6,60) X(ICOL),Y(ICOL),X(2*ICOL),Y(2*ICOL)
      90  CONTINUE
      RETURN
      END

```

SYMBOLIC REFERENCE MAP (R-3)

ENTRY POINTS	DEF LINE	REFERENCES
3	1	21
VARIABLES	SN	TYPE
230	1	INTEGER
227	1	COL
226	1	K
225	1	INC
0	KPTS	INTEGER
0	X	REAL
0	Y	REAL
FILE NAMES	MODE	
TAPE6	FMT	
INLINE FUNCTIONS	TYPE	WRITES
MOD	INTEGER	9
STATEMENT LABELS		13
0	40	INACTIVE
26	50	
157	60	FMT
52	70	
105	80	
162	90	

RELOCATION	REFS	6*9	6*13	6*17	DEFINED	9	13	17
	REFS	4*13	2*15	4*17	DEFINED	4	4*19	
	REFS	6	7	8	DEFINED	4	5	
	REFS	5	5*9	13	DEFINED	17	17	
	REFS	3	4	DEFINED	1	3	3	
ARRAY	REFS	2	3*9	3*13	15	3*17	2*19	
F.P.	REFS	1						
F.P.	DEFINED	2	3*9	3*13	15	3*17	2*19	
	DEFINED	1						

ARG	2	INTRIN	DEF LINE	REFERENCES
				4

APPENDIX C

	SUBROUTINE	COLUMNS	74/74	CPT=1		F7N 4.5+614	06/01/76	14.046.49	PAGE	2
LOOPS	LABEL	INDEX	FROM-TC	LENGTH	PROPERTIES	EXT REFS				
31	*	1	9 9	178						
55	*	1	13 13	178		EXT REFS				
110	*	1	17 17	178		EXT REFS				
STATISTICS	PROGRAM LENGTH		2578	175						

APPENDIX C

ROUTINE CHANGE	74/76 OPT=1	FTN 4.5+14	06/01/76 14.04.49	PAGE 1
1	SUBROUTINE CHANGE(NUMB,XLAB,YLAB,X,Y)		CHANGE 2	
	COMMON/D/ T16001,PP(600)		CHANGE 3	
	DIMENSION XTITLE(3),YTITLE(3),X(1600),Y(1600)		CHANGE 4	
5	DATA XTITLE/3*1H /,YTITLE/3*1H /		CHANGE 5	
	XTITLE(1)=1.5H		CHANGE 6	
	XTITLE(2)=1.0MPULSE WIDT		CHANGE 7	
	XTITLE(3)=0.0MH		CHANGE 8	
	YTITLE(1)=10H		CHANGE 9	
10	YTITLE(2)=1.0POWER		CHANGE 10	
	DO 5 I=1,3		CHANGE 11	
	XLAB(I)=XTITLE(I)		CHANGE 12	
	YLAB(I)=YTITLE(I)		CHANGE 13	
	CONTINUE		CHANGE 14	
15	DO 10 I=1,NUMB		CHANGE 15	
	X(I)=T(I)		CHANGE 16	
	Y(I)=PP(I)		CHANGE 17	
	10 CONTINUE		CHANGE 18	
	RETURN		CHANGE 19	
20	END		CHANGE 20	
			CHANGE 21	

SYMBOLIC REFERENCE MAP (R=3)

ENTRY POINTS	DEF LINE	REFERENCES	REFS	DEF LINE	REFERENCES	REFS	DEF LINE	REFERENCES	REFS
3 CHANGE	1	19		2012	2013	2016	2017	DEFINED	11 15
VARIABLES	SN TYPE	RELOCATION	REFS	15	DEFINED	1	2	DEFINED	11
42 1	INTEGER	F.P.	REFS	15	DEFINED	1	2	DEFINED	11
0 NUMD	REAL	ARRAY D	REFS	2	17				
1130 PP	REAL	ARRAY D	REFS	2	16				
0 T	REAL	ARRAY F,P.	REFS	3	DEFINED	1	16	DEFINED	1
0 X	REAL	ARRAY F,P.	REFS	4	DEFINED	1	12	DEFINED	1
0 XLAB	REAL	ARRAY F,P.	REFS	3	DEFINED	1	12	DEFINED	5
43 XTITLE	REAL	ARRAY F,P.	REFS	3	DEFINED	1	17	DEFINED	6
0 V	REAL	ARRAY F,P.	REFS	4	DEFINED	1	13	DEFINED	7
0 YLAB	REAL	ARRAY F,P.	REFS	3	DEFINED	1	5	DEFINED	9
46 YTITLE	REAL	ARRAY F,P.	REFS	13	DEFINED	5	9	DEFINED	10
STATEMENT LABELS		DEF LINE REFERENCES							
0 S		14 11							
0 10		18 15							
LOOPS	LABEL INDEX	FROM-TO LENGTH PROPERTIES							
20 5	I	11 14 38	INSTACK						
31 10	I	15 18 38	INSTACK						
COMMON BLOCKS	LENGTH	MEMBERS - BIAS NAME LENGTH							
D	1200	0 T (600)							
STATISTICS									
PROGRAM LENGTH		518	41						
CM LABELED COMMON LENGTH		22608	1200						
		600 PP	(600)						

APPENDIX D.--SAMPLE INPUT WHEN ISEM = 0

Sample input data are listed when all of the data in card sets 3 and 4 are used.

APPENDIX D

1	2	3	4	5	6	7	8	
10IN3600	0100E	C-A	FAIRCHILD					
03IN3600							R.PARSONS 7-23-73	
00101	10.000E-6	100.	100.	0.	10.000E-6	1.0		
	.10.	160.	160.	0.00E	0.00E C+			
00102	10.000E-6	110.	105.	.15	10.000E-6	1.0		
	.10.	160.	160.	0.00E	0.00E C+			
00103	10.000E-6	120.	115.	.60	2.2 E-6	1.0		
	.0.	160.	0.	0.00E	0.00E C+			
06IN3600								
00201	10.000E-6	60.000	60.	0.00E	10.000E-6	.300		
	.300	92.	92.	0.00E	0.00E C+			
00202	10.000E-6	70.	70.	0.	10. E-6	.3		
	.3	92.	92.	. E	. E C+			
00203	10.	E-6	80.	0.	10. E-6	0.3		
	.3	92.	92.	. E	. E C+			
00204	10.	E-6	90.	0.	10. E-6	0.2		
	.0.	92.	92.	. E	. E C+			
00205	10.	E-6	100.	80.	1.3	2.0 E-6	.3	
	.3	92.	92.	. E	. E C+ BRKDOWN NU VZ CHG			
00206	10.	E-6	110.	90.	2.2	.8 E-6	.3	
	.3	92.	4.	. E	. E C+			
03IN3600								
00301	10.	E-6	90.	80.	0.0	10. E-6	.3	
	.3	90.	90.	. E	. E C+			
00302	10.	E-6	90.	90.	0.	10. E-6	.3	
	.3	90.	90.	. E	. E C+			
00303	10.	E-6	100.	95.	0.7	3.0 E-6	.3	
	.1	90.	0.	. E	. E C+			
04IN3600								
00401	10.	E-6	80.	80.	0.0	10.0 E-6	.3	
	.3	98.	98.	. E	. E C+			
00402	10.	E-6	90.	90.	0.0	10. E-6	.3	
	.3	98.	98.	. E	. E C+			
00403	10.	E-6	100.	100.	0.0	10. E-6	.3	
	.3	98.	98.	. E	. E C+			
00404	10.	E-6	110.	105.	1.0	1.9 E-6	.3	
	.0	98.	0.	. E	. E C+			
03IN3600								
00501	10.	E-6	80.	80.	0.0	10.0 E-6	.3	
	.3	86.	86.	. E	. E C+			
00502	10.	E-6	90.	85.	.6	1.2 E-6	.3	
	.3	86.	83.	. E	. E C+ BRKDOWN DEVICE NU CG			
00503	10.	E-6	100.	90.	1.8	1.2 E-6	.3	
	.3	86.	12.	. E	. E C+			
03IN3600								
00601	10.	E-6	80.	80.	0.0	10. E-6	.3	
	.3	96.	86.	. E	. E C+			
00602	10.	E-6	90.	90.	0.0	10. E-6	.3	
	.3	86.	86.	. E	. E C+			
00603	10.	E-6	100.	90.	1.0	1.2 E-6	.3	
	.0	86.	0.0	. E	. E C+			

APPENDIX D

	1	2	3	4	5	6	7	8
04IN3600								
00701 10.	E-6	80.	80.	.	0.0	10.	E-6	.3
.	86.	86.	.	E	0.0	10.	E-6	.3
00702 10.	F-6	90.	90.	.	0.0	10.	E-6	.3
.	86.	86.	.	E	0.0	10.	E-6	.3
00703 10.	F-6	100.	95.	.	0.4	2.7	E-6	.3
.	86.	86.	.	E	0.4	2.7	E-6	.3
00704 10.	F-6	100.	90.	.	1.2	.8	E-6	.3
.	86.	17.	.	E	1.2	.8	E-6	.3
05IN3600								
00801 10.	F-6	80.	80.	.	0.0	10.	F-6	.3
.	88.	88.	.	E	0.0	10.	E-6	.3
00802 10.	F-6	90.	90.	.	0.0	10.	E-6	.3
.	88.	88.	.	E	0.0	10.	E-6	.3
00803 10.	F-6	100.	100.	.	0.0	10.0	E-6	.3
.	88.	88.	.	E	0.0	10.0	E-6	.3
00804 10.	F-6	110.	110.	.	0.0	10.	E-6	.3
.	88.	88.	.	E	0.0	10.	E-6	.3
00805 10.	F-6	118.	105.	.	1.2	1.0	F-6	.3
.	88.	10.	.	E	1.2	1.0	F-6	.3
04IN3600								
00901 5.0	F-6	80.	80.	.	0.0	5.0	E-6	.3
.	93.	93.	.	E	0.0	5.0	E-6	.3
00902 5.0	F-6	90.	90.	.	0.0	5.0	E-6	.3
.	93.	93.	.	E	0.0	5.0	E-6	.3
00903 5.0	F-6	100.	95.	.	0.6	2.8	E-6	.3
.	93.	93.	.	E	0.6	2.8	E-6	.3
00904 5.0	F-6	112.	100.	.	0.9	0.9	E-6	.3
.	93.	60.	.	E	0.9	0.9	E-6	.3
04IN3600								
01001 5.0	F-6	80.	80.	.	0.0	5.0	E-6	.3
.	93.	93.	.	E	0.0	5.0	E-6	.3
01002 5.0	F-6	90.	90.	.	0.0	5.0	E-6	.3
.	93.	93.	.	E	0.0	5.0	E-6	.3
01003 5.	F-6	100.	97.	.	0.2	1.1	E-6	.3
.	93.	93.	.	E	0.2	1.1	E-6	.3
01004 5.0	F-6	110.	103.	.	0.9	1.8	E-6	.3
.	93.	80.	.	E	0.9	1.8	E-6	.3

APPENDIX E.--SAMPLE INPUT WHEN ISEM = 1

Sample input data are listed when only pulse width versus power data on card set 5 are used.

APPENDIX E

1 2 3 4 5 6 7 F

1 2
10IN3600 DIODE
REVERSE FAILURE
.800E-06 .110E+03
.800E-05 .200E+03
.900E-06 .900E+02
.100E-05 .130E+03
.120E-05 .900E+02
.120E-05 .160E+03
.160E-05 .930E+02
.190E-05 .110E+03
.220E-05 .690E+02
.300E-05 .670E+02

C-A FAIRCHILD
PULSE WIDTH POKER

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